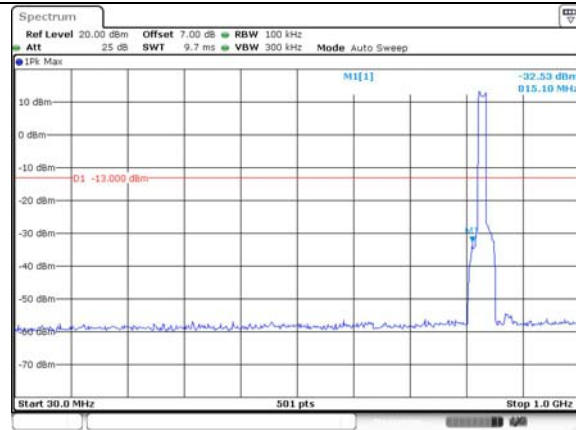


Spurious Emissions at Antenna Terminal

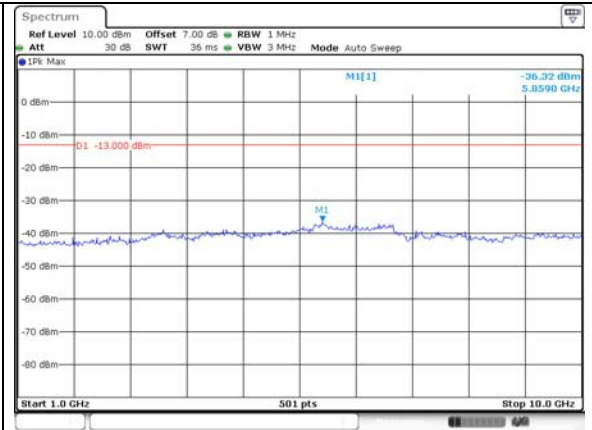
Channel

15MHz Bandwidth QPSK

Lowest

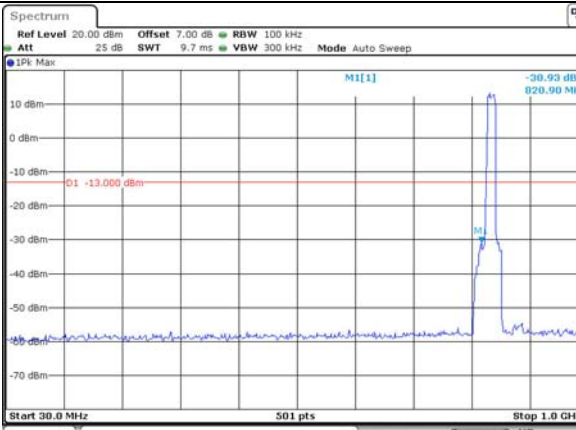


ProjectNo.:CR231061510-RF Testers:Claire Liu
Date: 13.NOV.2023 17:03:53

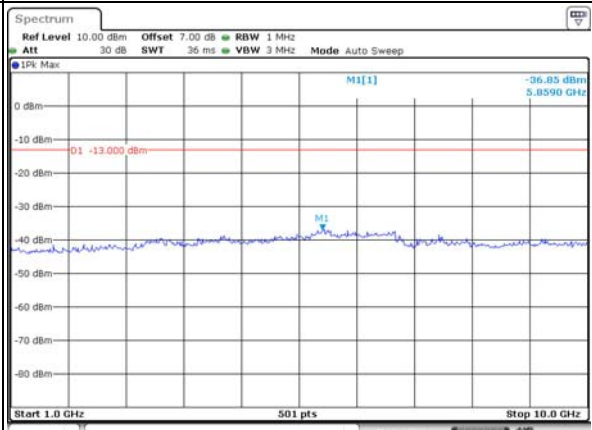


ProjectNo.:CR231061510-RF Testers:Claire Liu
Date: 13.NOV.2023 17:04:22

Middle

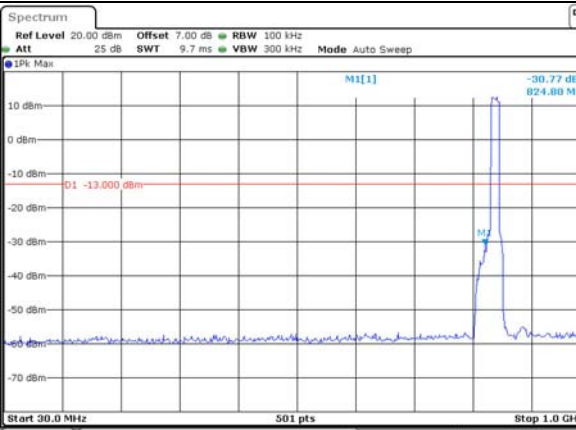


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Date: 13.NOV.2023 17:04:57

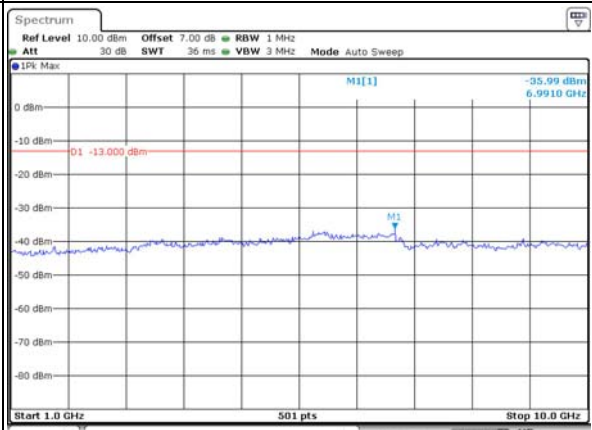


ProjectNo.:CR231061510-RF Testers:Claire Liu
Date: 13.NOV.2023 17:05:26

Highest

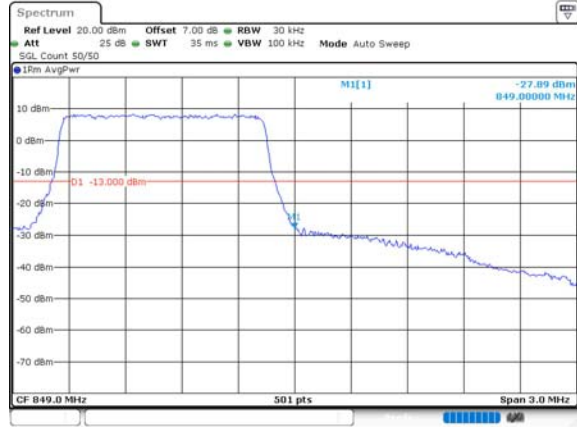
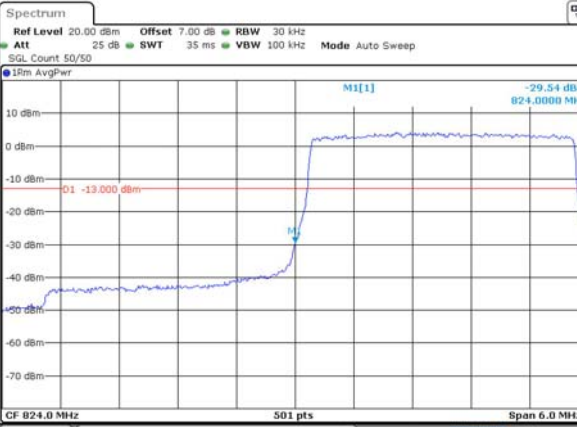
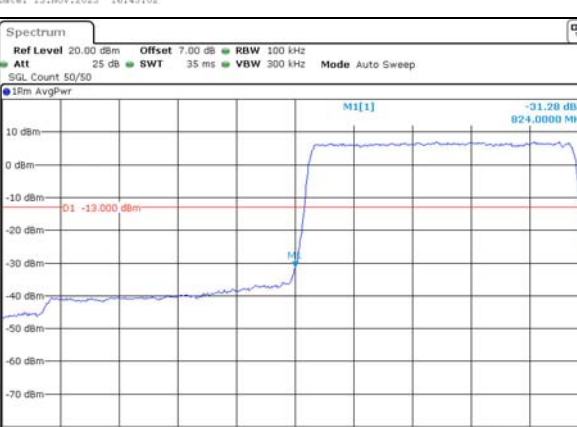
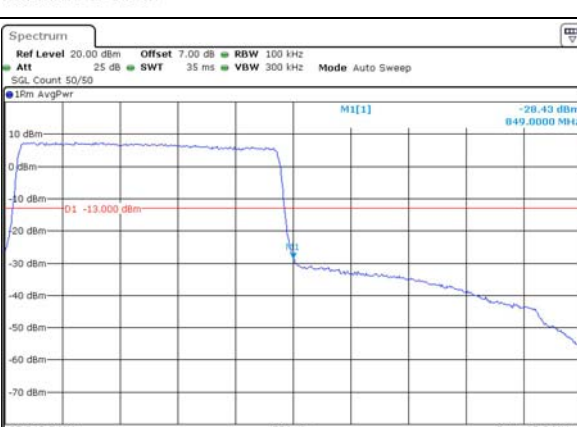


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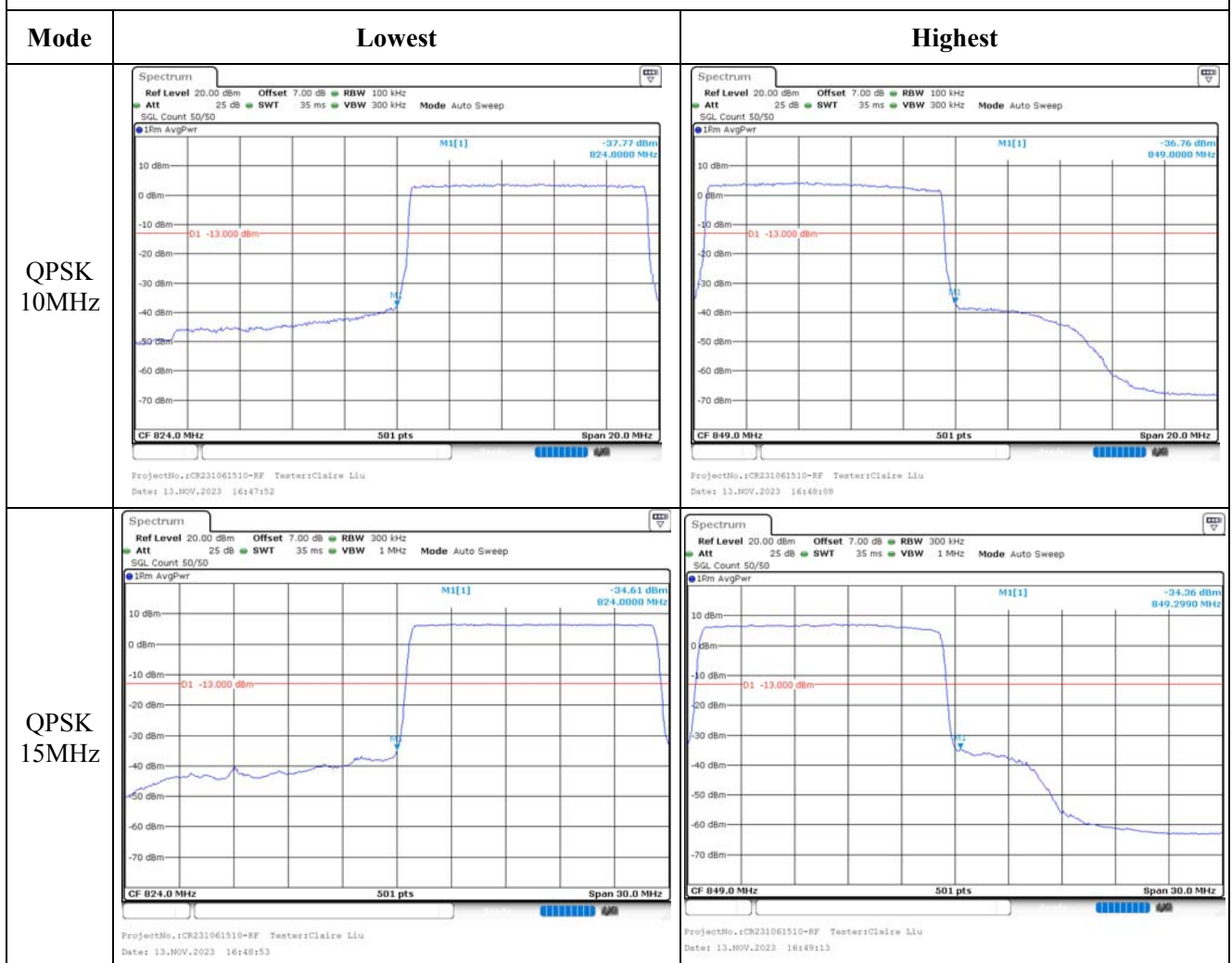


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Date: 13.NOV.2023 17:06:20

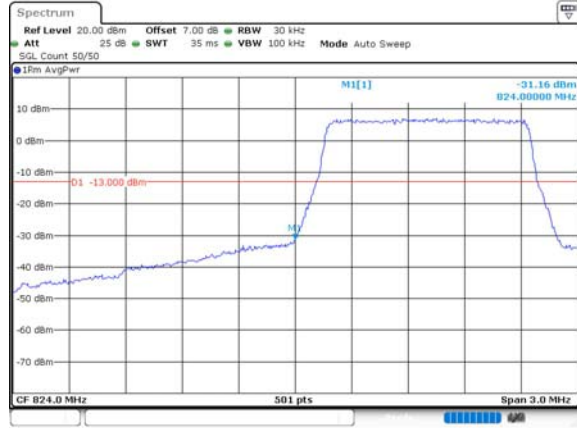
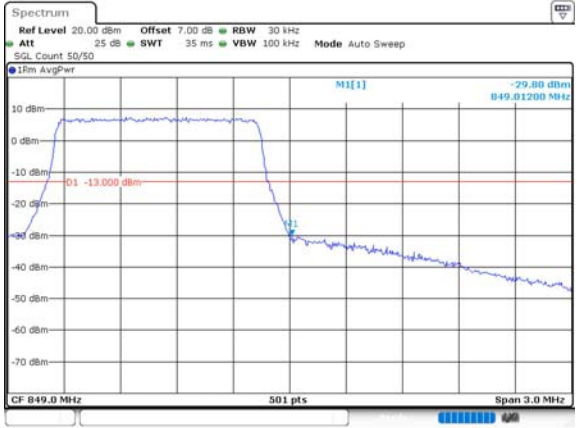
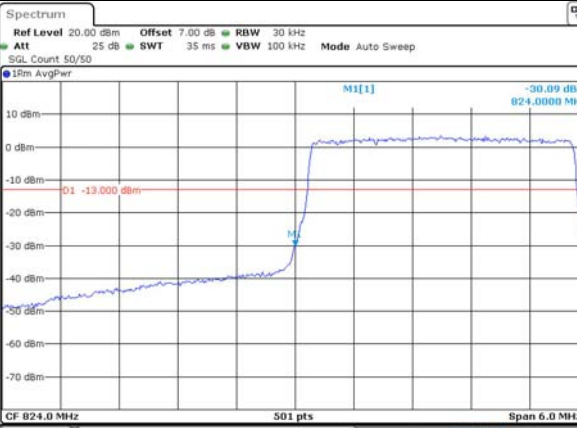
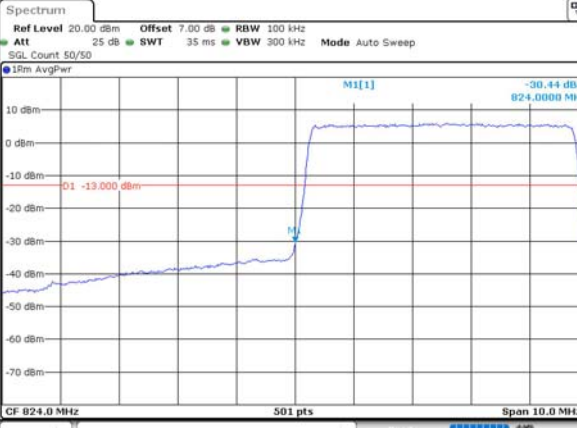
Out of band emission, Band Edge

Mode	Lowest	Highest
QPSK 1.4MHz	 ProjectNo.:CR231061510-RF Testers:Claire Liu Date: 13.NOV.2023 16:43:59	 ProjectNo.:CR231061510-RF Testers:Claire Liu Date: 13.NOV.2023 16:44:11
QPSK 3MHz	 ProjectNo.:CR231061510-RF Testers:Claire Liu Date: 13.NOV.2023 16:45:02	 ProjectNo.:CR231061510-RF Testers:Claire Liu Date: 13.NOV.2023 16:45:17
QPSK 5MHz	 ProjectNo.:CR231061510-RF Testers:Claire Liu Date: 13.NOV.2023 16:46:55	 ProjectNo.:CR231061510-RF Testers:Claire Liu Date: 13.NOV.2023 16:47:10

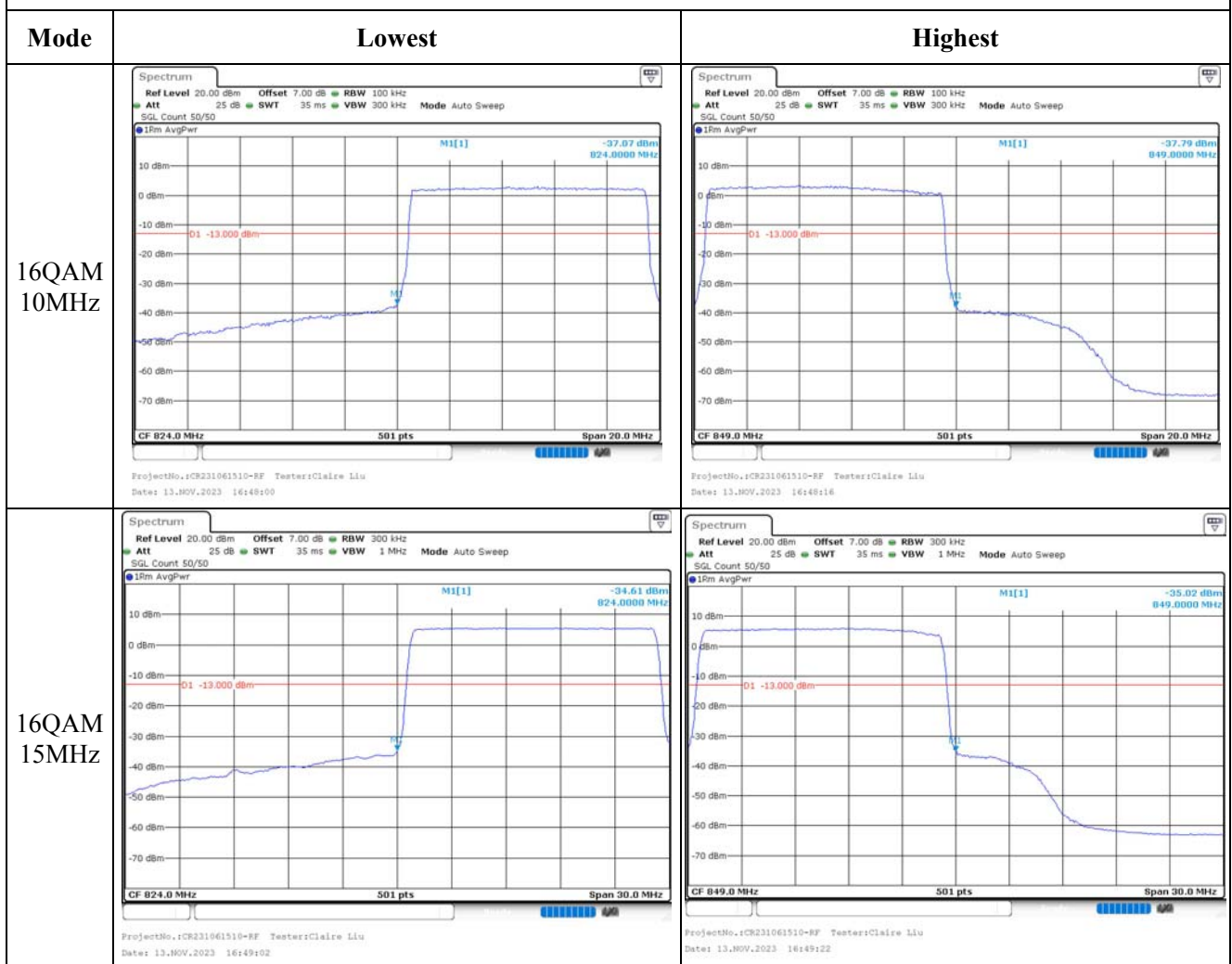
Out of band emission, Band Edge



Out of band emission, Band Edge

Mode	Lowest	Highest
16QAM 1.4MHz	 ProjectNo.: CR231061510-RF Tester: Claire Liu Date: 13.NOV.2023 16:44:04	 ProjectNo.: CR231061510-RF Tester: Claire Liu Date: 13.NOV.2023 16:44:16
16QAM 3MHz	 ProjectNo.: CR231061510-RF Tester: Claire Liu Date: 13.NOV.2023 16:45:09	 ProjectNo.: CR231061510-RF Tester: Claire Liu Date: 13.NOV.2023 16:45:23
16QAM 5MHz	 ProjectNo.: CR231061510-RF Tester: Claire Liu Date: 13.NOV.2023 16:47:02	 ProjectNo.: CR231061510-RF Tester: Claire Liu Date: 13.NOV.2023 16:47:17

Out of band emission, Band Edge



4.14 Antenna Port Test Data and Results for LTE Band 38

Serial Number:	2CIM-1	Test Date:	2023/11/12~2023/12/9
Test Site:	RF	Test Mode:	Transmitting
Tester:	Claire Liu	Test Result:	Pass

Environmental Conditions:

Temperature: (°C)	24.7~25.5	Relative Humidity: (%)	53~62	ATM Pressure: (kPa)	100.1~102
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Test Equipment List and Details:

Manufacturer	Description	Model	Serial Number	Calibration Date	Calibration Due Date
R&S	Spectrum Analyzer	FSV40	101590	2022/11/25	2023/11/24
zhuoxiang	Coaxial Cable	SMA-178	211002	Each time	N/A
Minl-Circuits	Power Splitter	ZFRSC-183-S+	S F448201619	Each time	N/A
R&S	Wideband Radio Communication Tester	CMW500	143458	2023/3/31	2024/3/30
BACL	TEMP&HUMI Test Chamber	BTH-150-40	30174	2023/3/31	2024/3/30
UNI-T	Multimeter	UT39A+	C210582554	2023/9/28	2024/9/27
ZHAOXIN	DC Power Supply	RXN-6010D	21R6010D0912386	2023/9/28	2024/9/27
R&S	Spectrum Analyzer	FSV40	101590	2023/11/16	2024/11/15

* Statement of Traceability: China Certification ICT Co., Ltd (Dongguan) attests that all calibrations have been performed, traceable to National Primary Standards and International System of Units (SI).

Test Frequency For Each Mode:

Operation Bandwidth	Lowest Frequency (MHz)	Middle Frequency (MHz)	Highest Frequency (MHz)
5MHz	2572.5	2595	2617.5
10MHz	2575	2595	2615
15MHz	2577.5	2595	2612.5
20MHz	2580	2595	2610

Test Data:**RF Output Power**

Test Bandwidth & Modulation	Resource Block & RB offset	Conducted Average Output Power(dBm)			Maximum EIRP (dBm)	EIRP Limit (dBm)
		Lowest Channel	Middle Channel	Highest Channel		
5MHz QPSK	RB1#0	19	19.01	19.12	18.38	33
	RB1#13	19.15	19.15	19.26		
	RB1#24	19.04	19.01	19.16		
	RB15#0	18.02	18.05	18.18		
	RB15#10	18.09	18.06	18.17		
	RB25#0	18.02	18.03	18.15		
5MHz 16QAM	RB1#0	17.98	18.11	18.35	17.63	33
	RB1#13	18.16	18.23	18.51		
	RB1#24	18.02	18.09	18.4		
	RB15#0	17.02	17.13	17.27		
	RB15#10	17.03	17.13	17.26		
	RB25#0	17.13	17.17	17.24		
10MHz QPSK	RB1#0	19.06	19.15	19.21	18.43	33
	RB1#25	19.14	19.2	19.31		
	RB1#49	19.12	19.17	19.29		
	RB25#0	18.02	18.06	18.16		
	RB25#25	18.1	18.09	18.19		
	RB50#0	18.11	18.12	18.19		
10MHz 16QAM	RB1#0	18.31	18.04	18.29	17.52	33
	RB1#25	18.37	18.12	18.4		
	RB1#49	18.36	18.08	18.4		
	RB25#0	17.07	17.19	17.28		
	RB25#25	17.15	17.22	17.29		
	RB50#0	17.13	17.19	17.28		
15MHz QPSK	RB1#0	19.06	19.09	19.11	18.45	33
	RB1#38	19.21	19.22	19.33		
	RB1#74	19.1	19.19	19.26		
	RB36#0	18	18.05	18.1		
	RB36#39	18.01	18.11	18.19		
	RB75#0	18.01	18.09	18.15		
15MHz 16QAM	RB1#0	17.97	18.28	18.33	17.67	33
	RB1#38	18.12	18.45	18.55		
	RB1#74	18.03	18.4	18.49		
	RB36#0	17.04	17.2	17.16		
	RB36#39	17.07	17.26	17.25		
	RB75#0	17.06	17.17	17.17		
20MHz QPSK	RB1#0	18.91	18.91	19.05	18.51	33
	RB1#50	19.18	19.19	19.39		
	RB1#99	19.11	19.07	19.27		

20MHz 16QAM	RB50#0	18.03	18.04	18.07	17.69	33
	RB50#50	18.1	18.12	18.17		
	RB100#0	18.07	18.06	18.12		
	RB1#0	18	17.92	18.24		
	RB1#50	18.27	18.17	18.57		
	RB1#99	18.18	18.07	18.48		
	RB50#0	17.08	17.15	17.17		
	RB50#50	17.14	17.24	17.26		
	RB100#0	17.13	17.15	17.19		

Note: EIRP=Conducted Power(dBm) - Lc(dB) + Gr(dBi)

Result:

Pass

Peak-to-average Ratio(PAR)

Test Bandwidth & Modulation	Resource Block & RB offset	Peak-to-average Ratio(dB)			Limit (dB)
		Lowest Channel	Middle Channel	Highest Channel	
20MHz QPSK	RB1#0	9.77	9.33	9.42	13
	RB100#0	8.38	8.35	8.35	13
20MHz 16QAM	RB1#0	10.35	10	10.26	13
	RB100#0	9.91	9.88	9.8	13
				Result:	Pass

Occupied Bandwidth

Operation Mode	99% Occupied Bandwidth (MHz)			26 dB Occupied Bandwidth (MHz)		
	Low Channel	Middle channel	High Channel	Low Channel	Middle Channel	High Channel
5MHz QPSK	4.511	4.980	4.511	5.040	4.511	4.940
5MHz 16QAM	4.511	5.040	4.511	4.940	4.511	4.940
10MHz QPSK	8.942	9.680	8.942	9.680	8.942	9.560
10MHz 16QAM	8.942	9.520	8.942	9.520	8.942	9.920
15MHz QPSK	13.533	14.640	13.413	14.760	13.413	15.000
15MHz 16QAM	13.533	14.640	13.533	14.940	13.533	15.480
20MHz QPSK	17.884	19.200	17.884	19.280	17.884	19.360
20MHz 16QAM	17.884	19.280	17.884	19.200	17.884	19.120

Note: The test plots please refer to the Plots of Occupied Bandwidth

Spurious Emissions at Antenna Terminal

Result:	Pass, Please refer to the test plots of Spurious Emissions at Antenna Terminal.
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Out of band emission, Band Edge

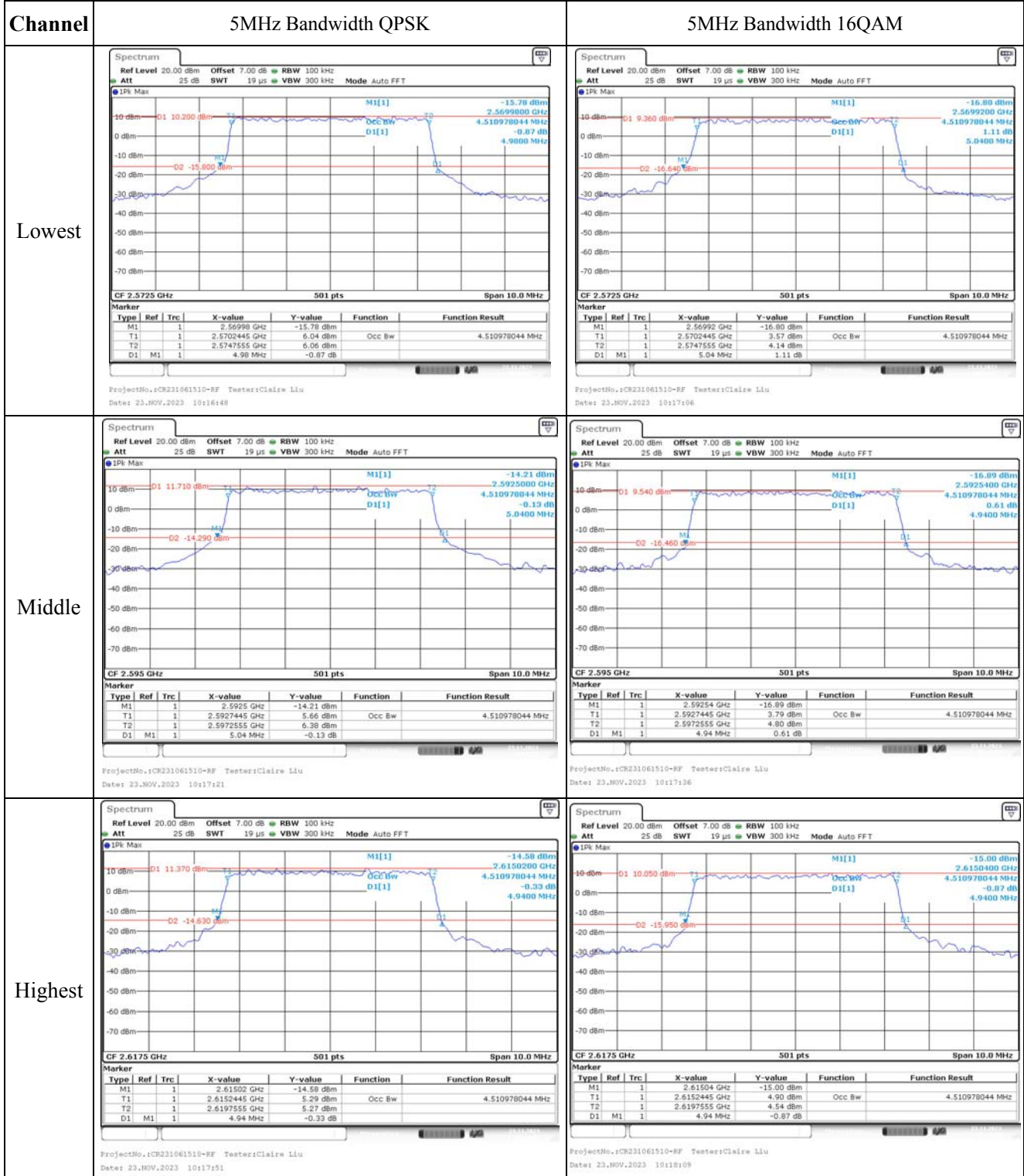
Result:	Pass, Please refer to the test plots of Out of band emission, Band Edge.
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Frequency Stability						
Test Mode:	20M QPSK	Test Channel: Lowest for Lower Edge,Highest for Upper Edge				
Test Item	Temperature (°C)	Voltage (V _{DC})	Lower Edge (MHz)		Upper Edge (MHz)	
			Result	Limit	Result	Limit
Frequency Stability vs. Temperature	-30	3.91	2570.403	2570.00	2619.656	2620
	-20	3.91	2570.452	2570.00	2619.639	2620
	-10	3.91	2570.441	2570.00	2619.583	2620
	0	3.91	2570.431	2570.00	2619.669	2620
	10	3.91	2570.483	2570.00	2619.623	2620
	20	3.91	2570.400	2570.00	2619.680	2620
	30	3.91	2570.407	2570.00	2619.582	2620
	40	3.91	2570.440	2570.00	2619.677	2620
	50	3.91	2570.447	2570.00	2619.655	2620
Frequency Stability vs. Voltage	20	3.45	2570.410	2570.00	2619.652	2620
	20	4.5	2570.481	2570.00	2619.629	2620
					Result:	Pass

Test Mode:	20M 16QAM	Test Channel: Lowest for Lower Edge,Highest for Upper Edge				
Test Item	Temperature (°C)	Voltage (V _{DC})	Lower Edge (MHz)		Upper Edge (MHz)	
			Result	Limit	Result	Limit
Frequency Stability vs. Temperature	-30	3.91	2570.406	2570.00	2619.464	2620
	-20	3.91	2570.422	2570.00	2619.450	2620
	-10	3.91	2570.409	2570.00	2619.463	2620
	0	3.91	2570.401	2570.00	2619.512	2620
	10	3.91	2570.414	2570.00	2619.478	2620
	20	3.91	2570.400	2570.00	2619.520	2620
	30	3.91	2570.422	2570.00	2619.511	2620
	40	3.91	2570.446	2570.00	2619.491	2620
	50	3.91	2570.431	2570.00	2619.486	2620
Frequency Stability vs. Voltage	20	3.45	2570.416	2570.00	2619.507	2620
	20	4.5	2570.497	2570.00	2619.460	2620
					Result:	Pass

Test Plots(Note: The 7.0dB is the Insertion loss of the RF cable, Power Splitter and DC Block, which was offset into the Spectrum Analyzer):

Occupied Bandwidth



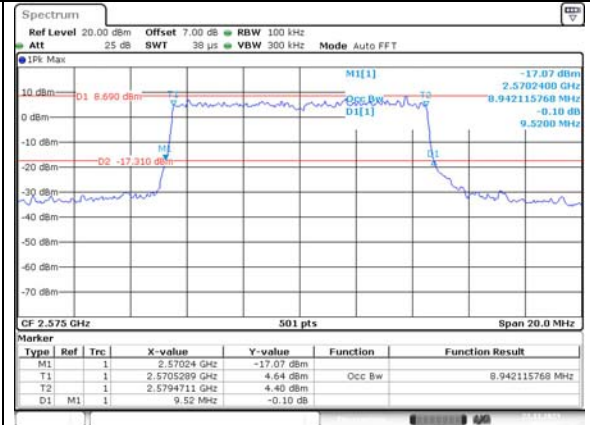
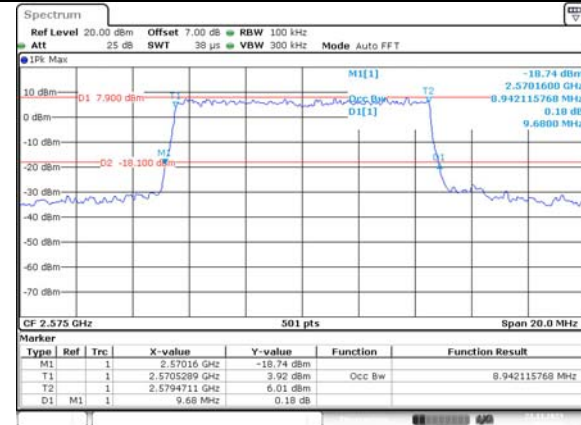
Occupied Bandwidth

Channel

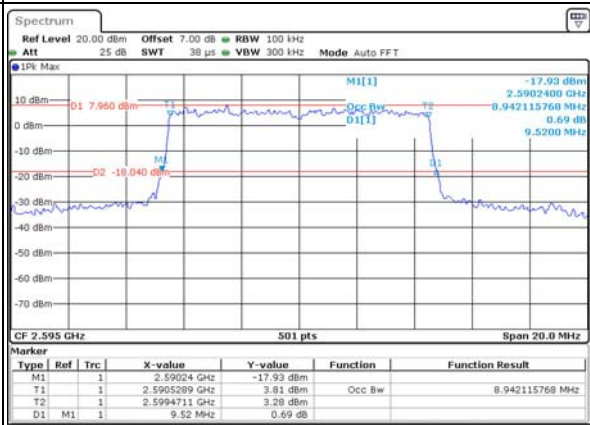
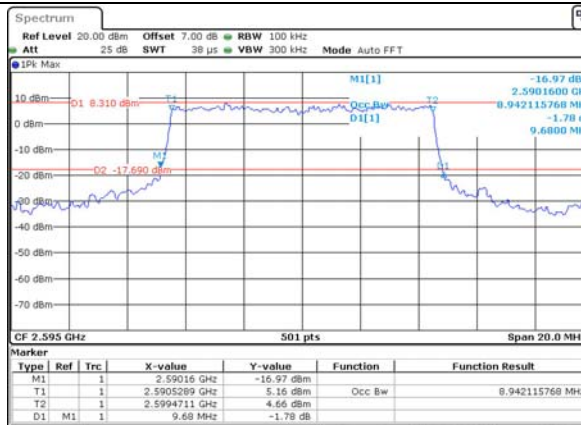
10MHz Bandwidth QPSK

10MHz Bandwidth 16QAM

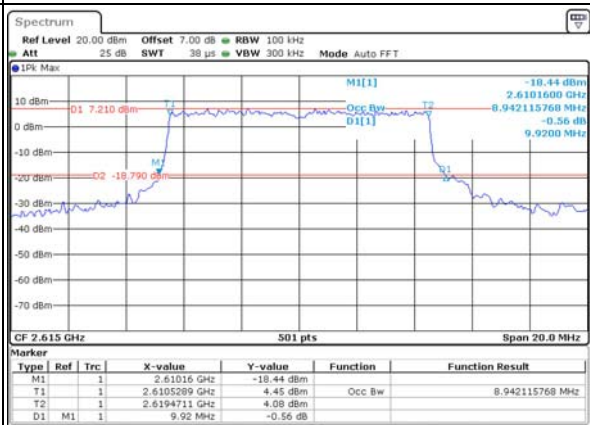
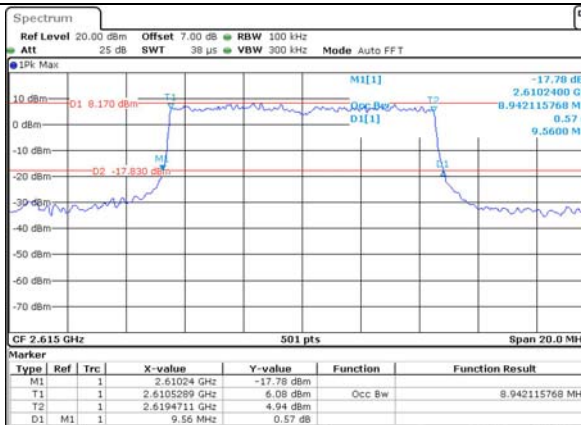
Lowest



Middle



Highest



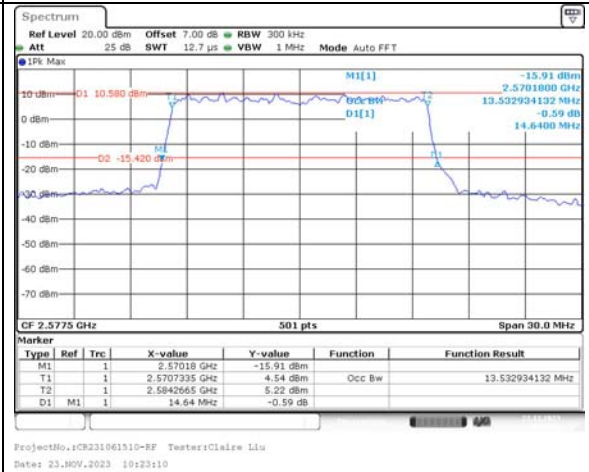
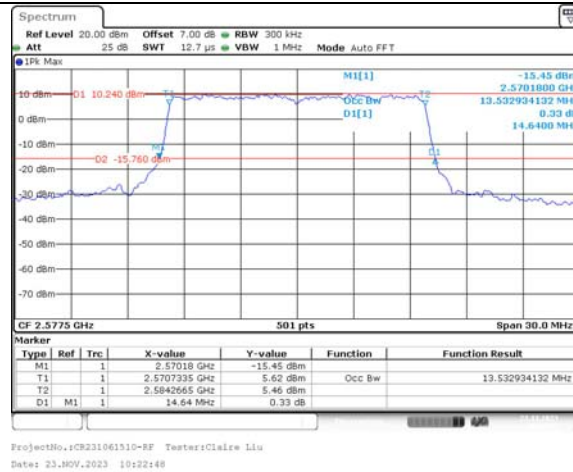
Occupied Bandwidth

Channel

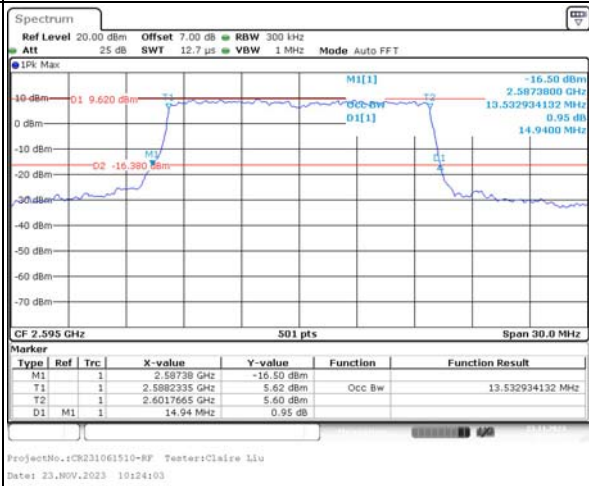
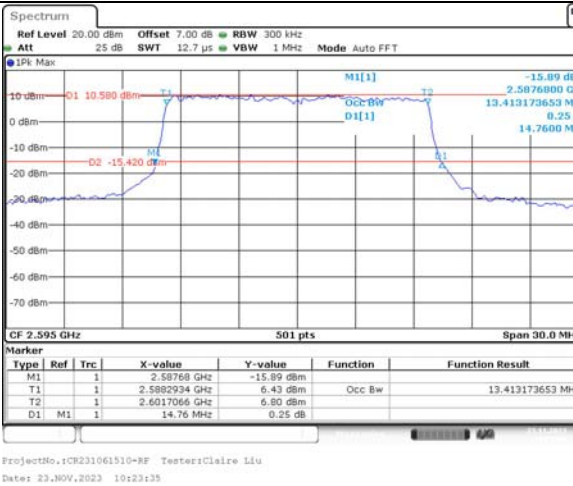
15MHz Bandwidth QPSK

15MHz Bandwidth 16QAM

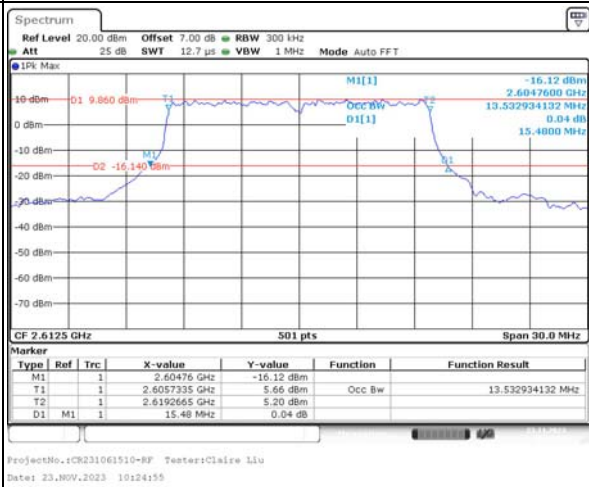
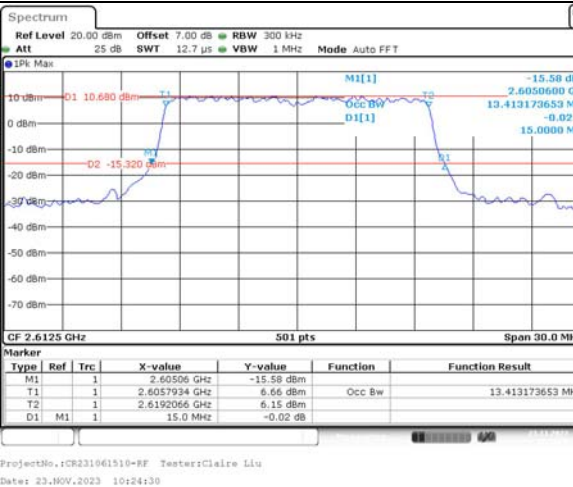
Lowest



Middle



Highest



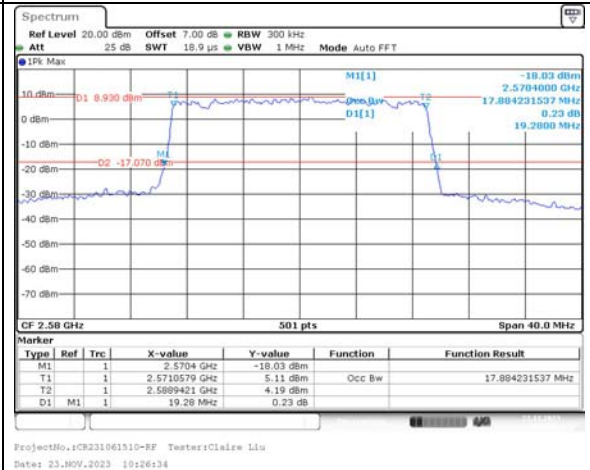
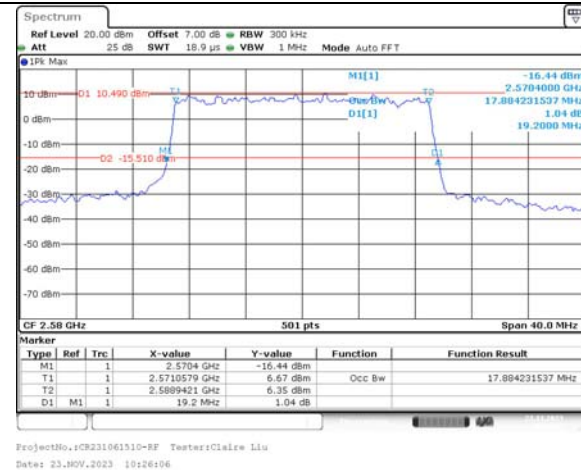
Occupied Bandwidth

Channel

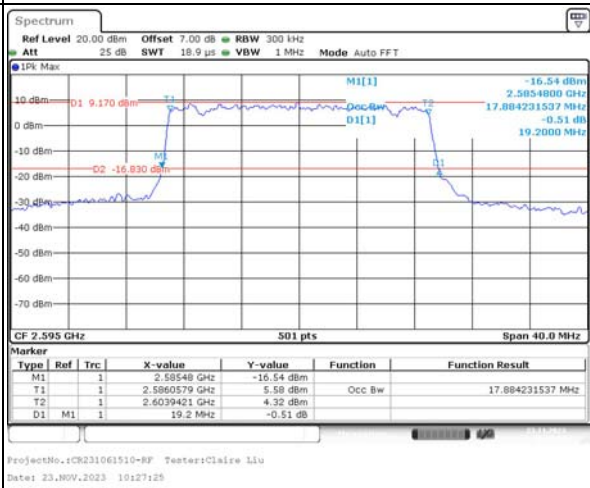
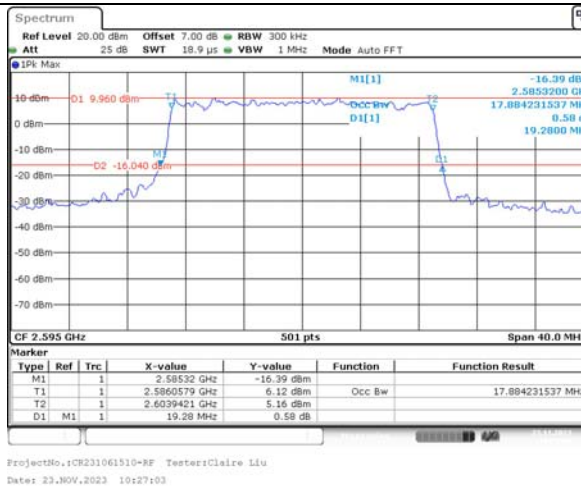
20MHz Bandwidth QPSK

20MHz Bandwidth 16QAM

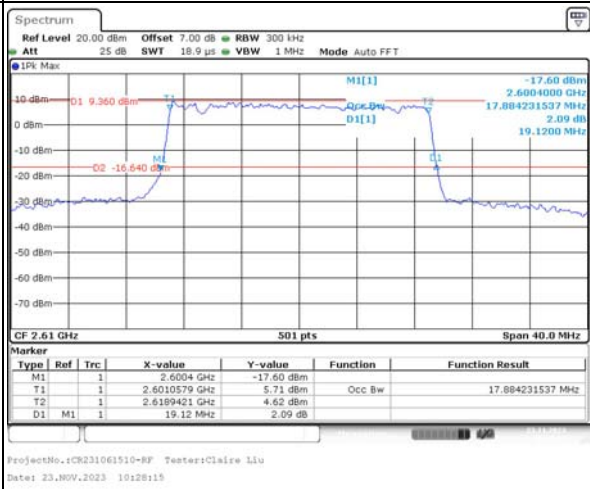
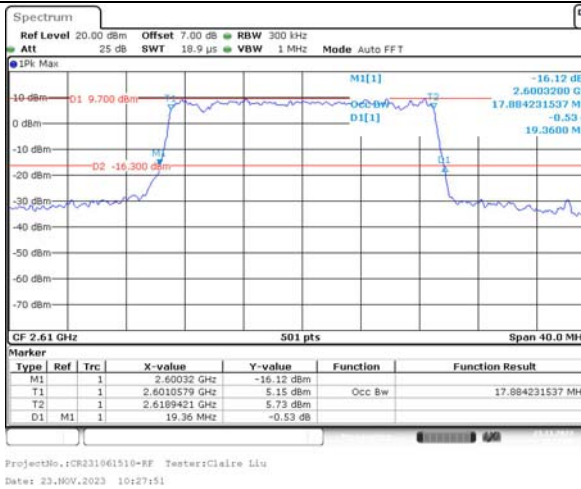
Lowest



Middle



Highest

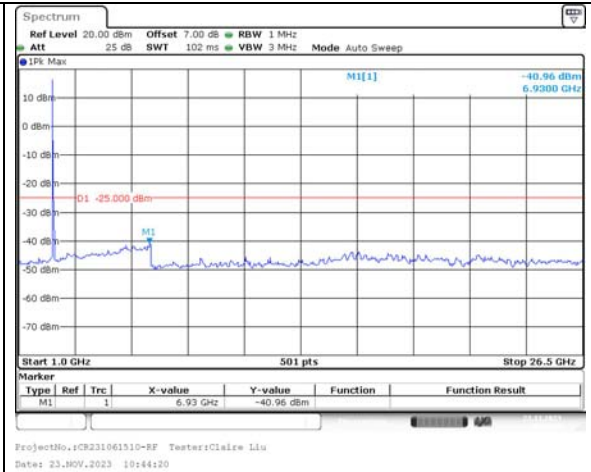
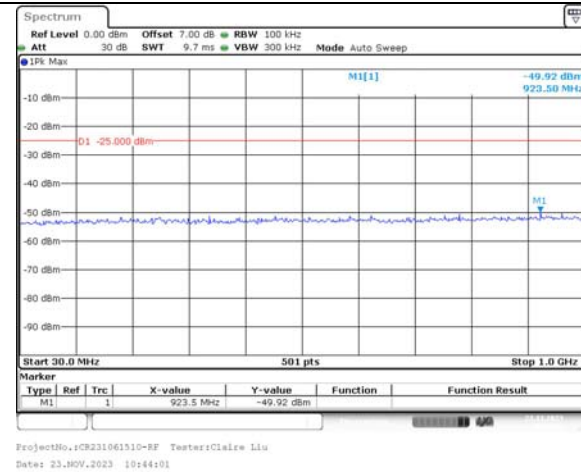


Spurious Emissions at Antenna Terminal

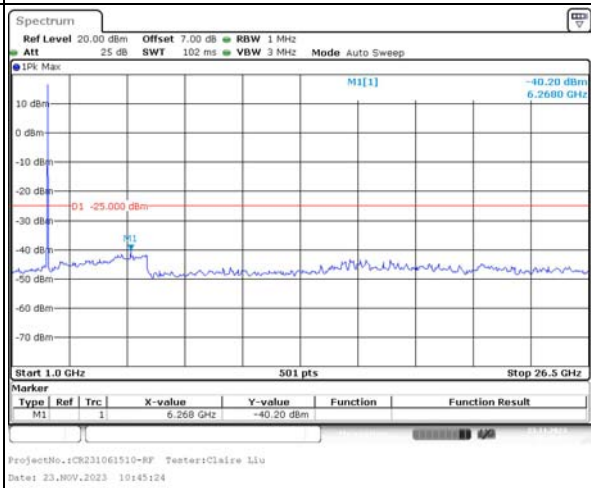
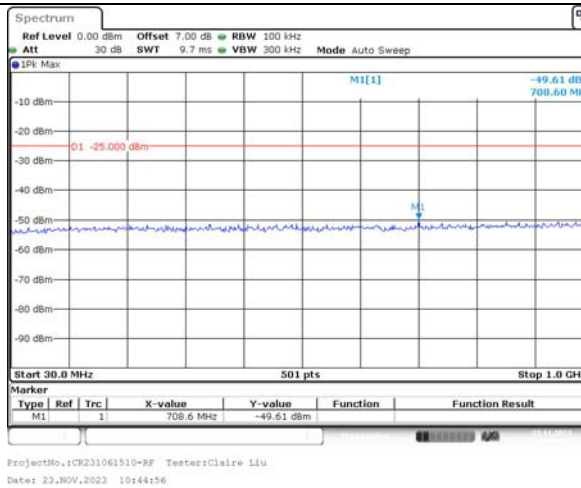
Channel

5MHz Bandwidth QPSK

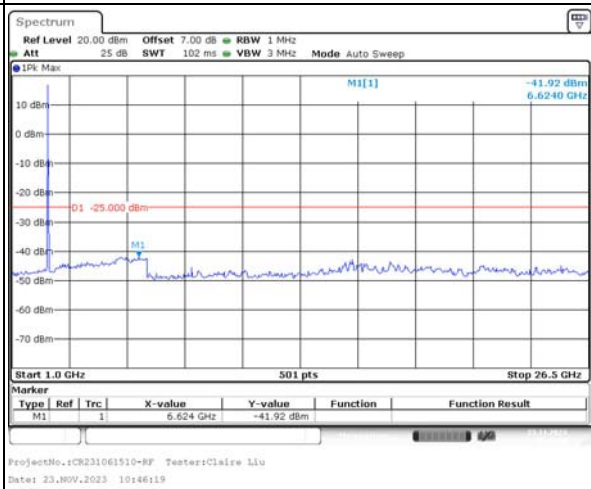
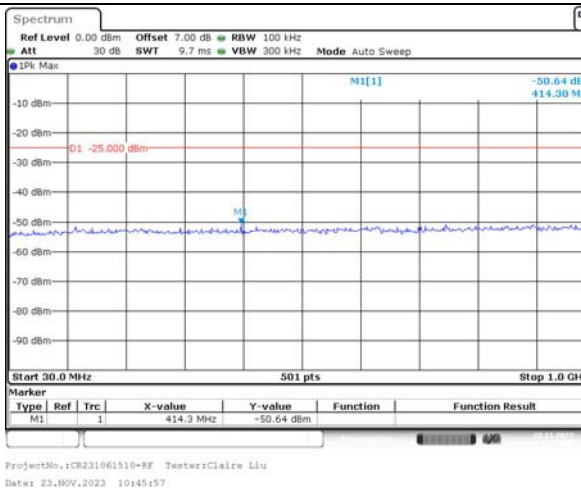
Lowest



Middle



Highest

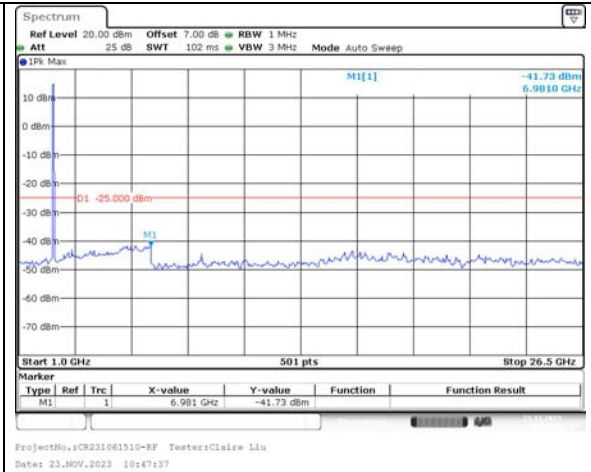
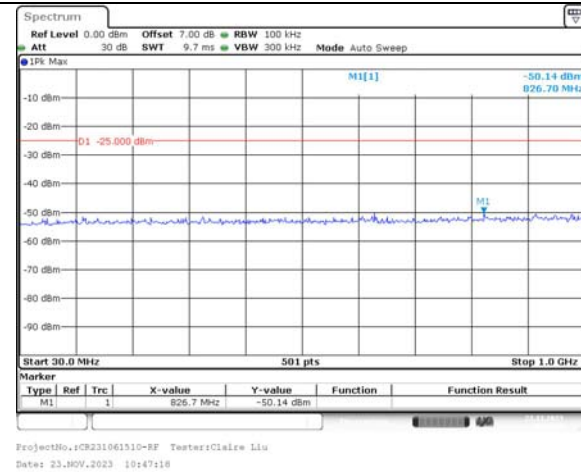


Spurious Emissions at Antenna Terminal

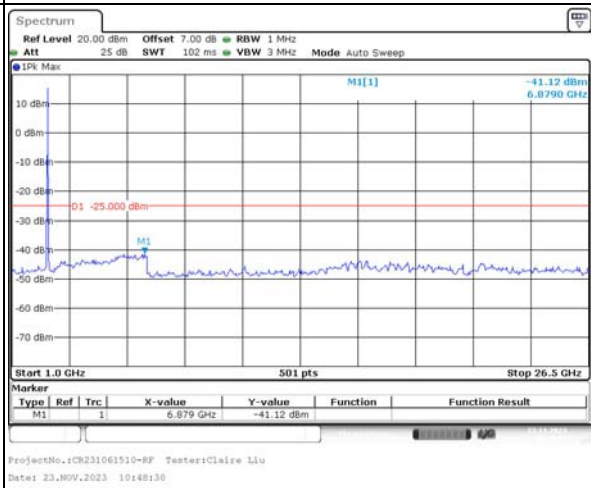
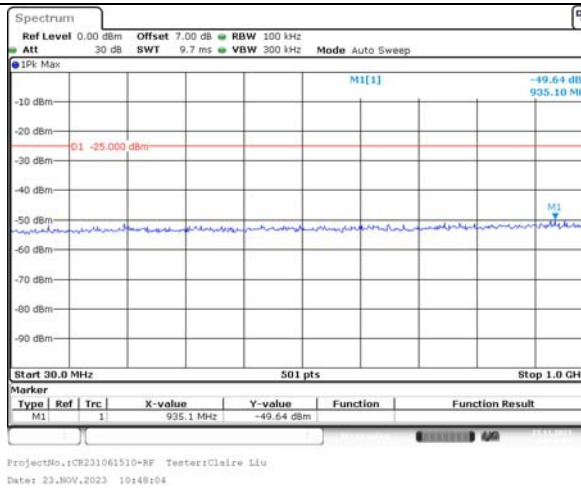
Channel

10MHz Bandwidth QPSK

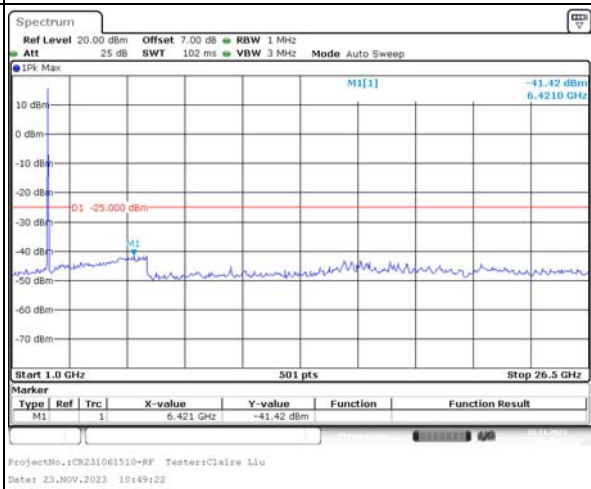
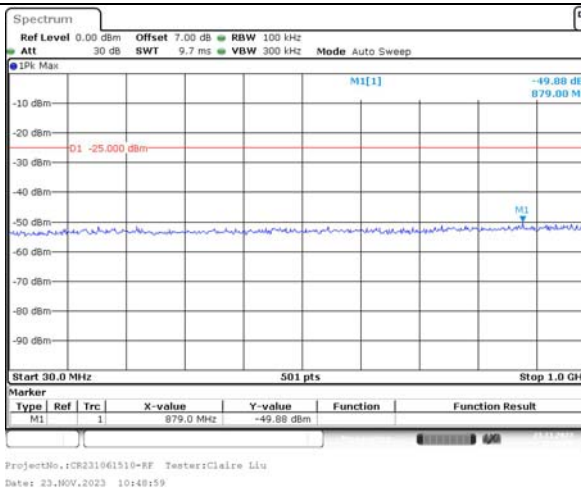
Lowest



Middle



Highest

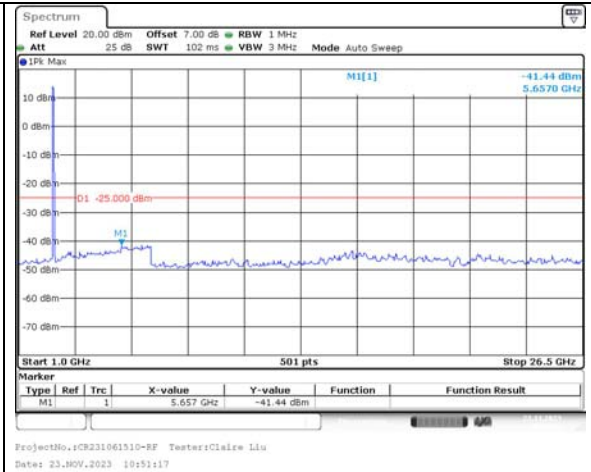
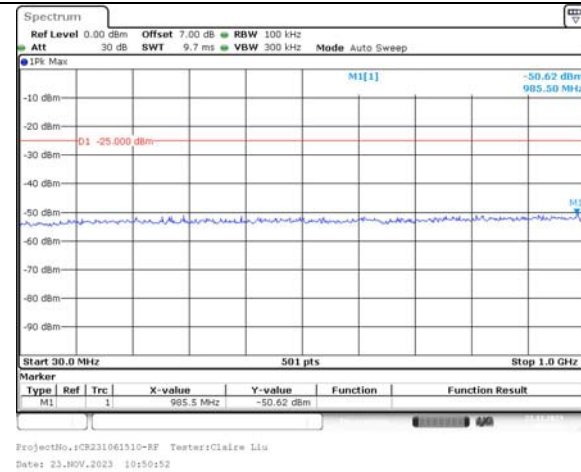


Spurious Emissions at Antenna Terminal

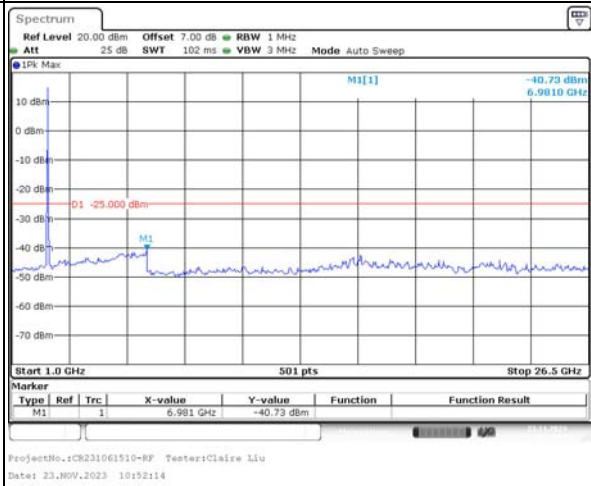
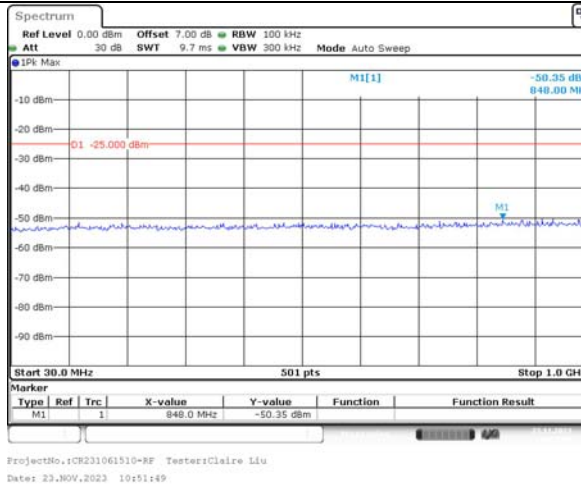
Channel

15MHz Bandwidth QPSK

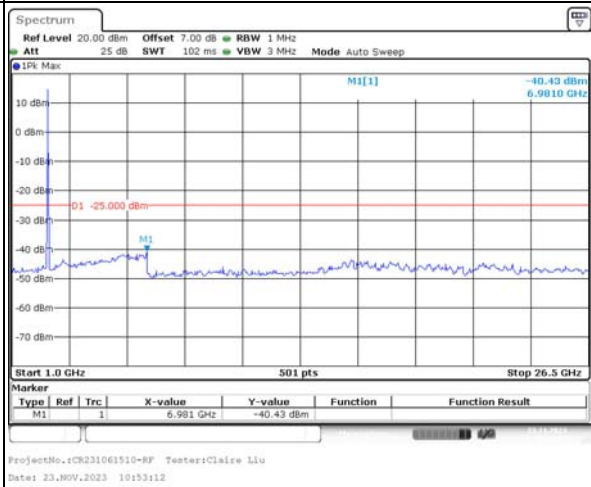
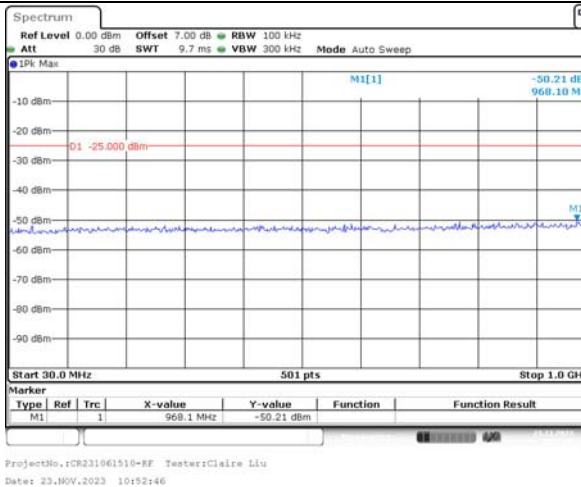
Lowest



Middle



Highest

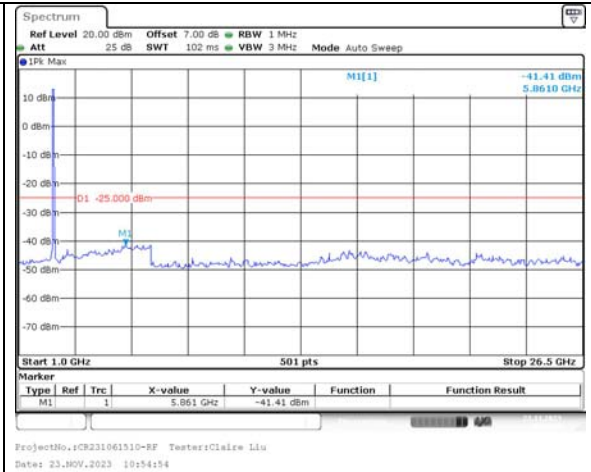
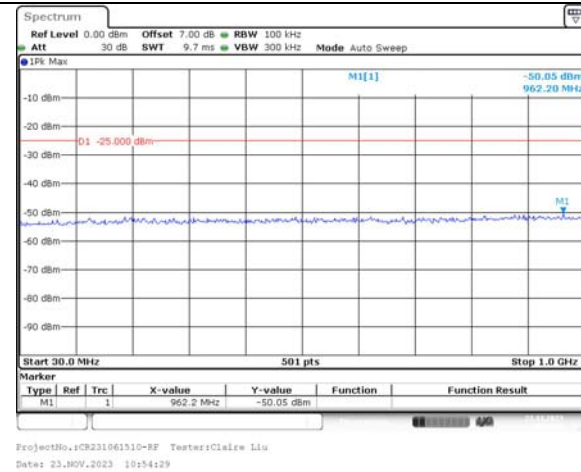


Spurious Emissions at Antenna Terminal

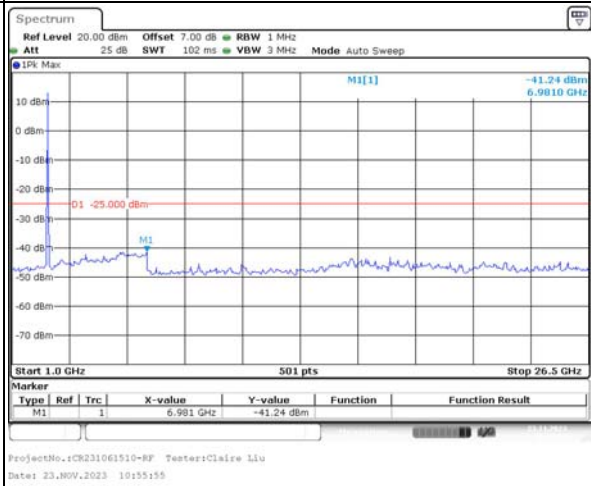
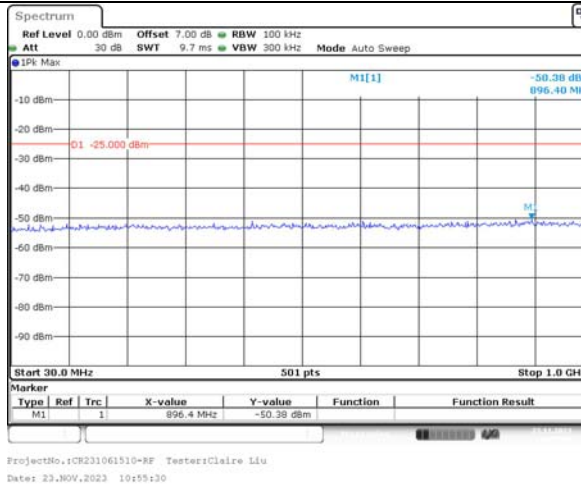
Channel

20MHz Bandwidth QPSK

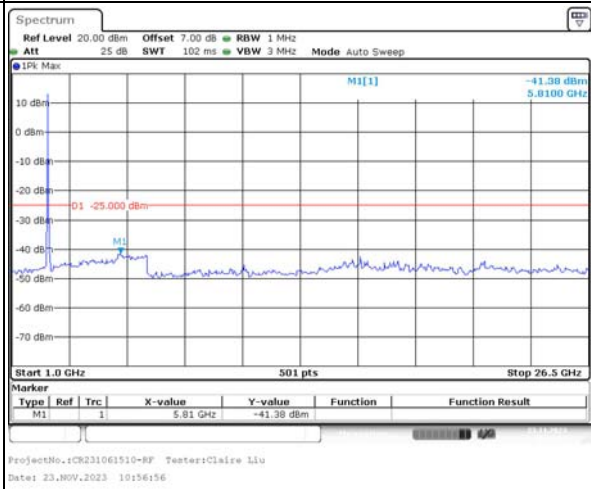
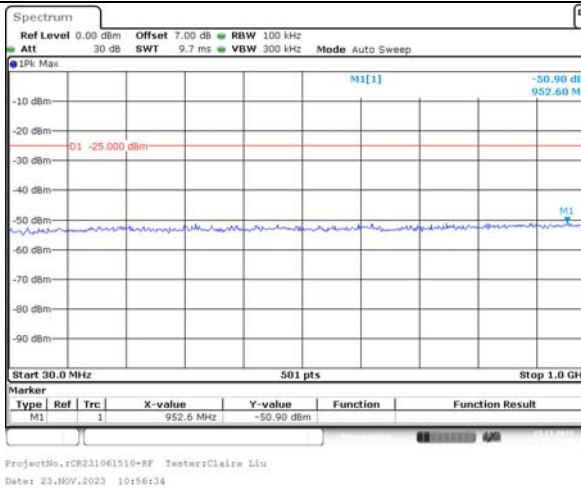
Lowest



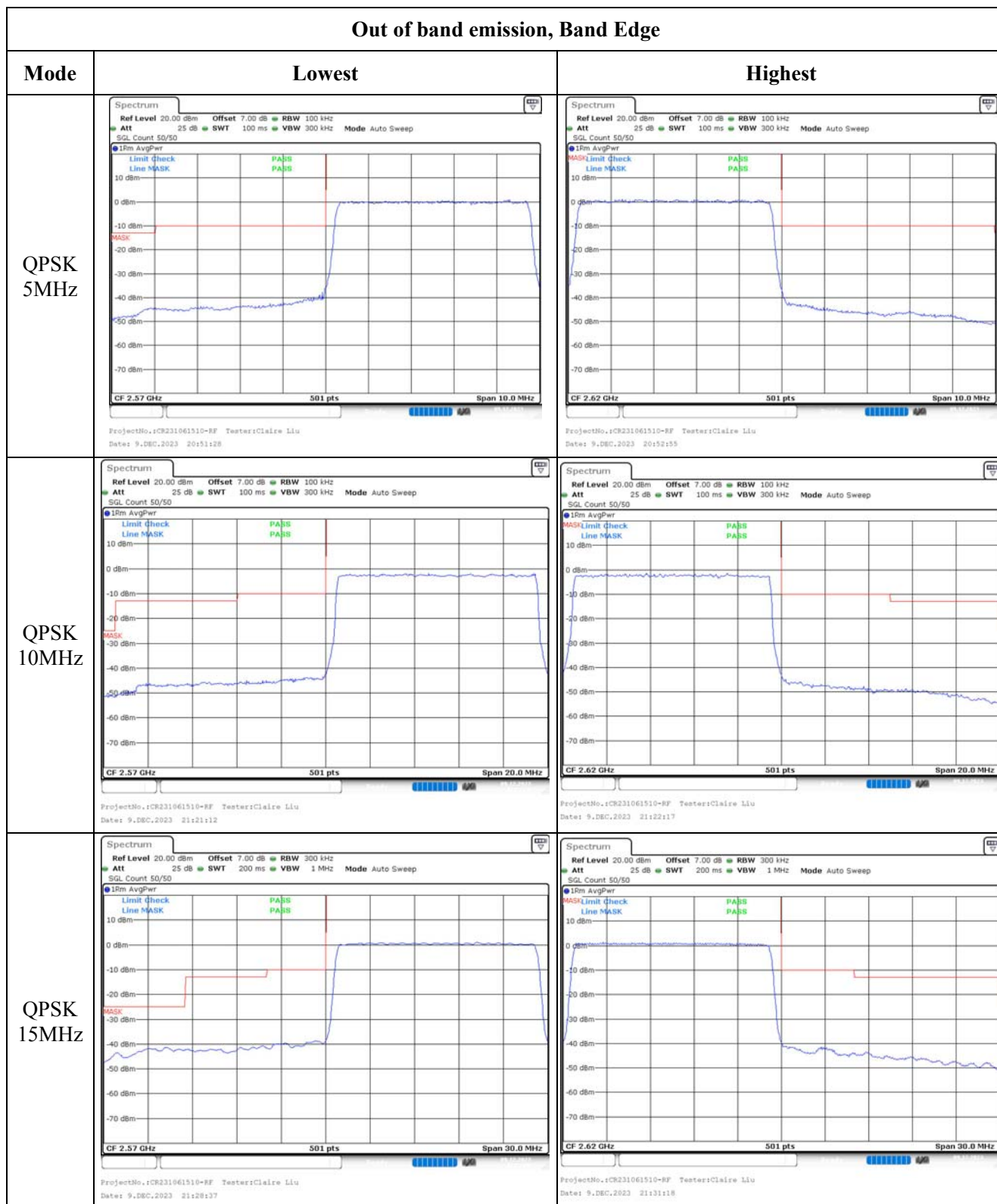
Middle

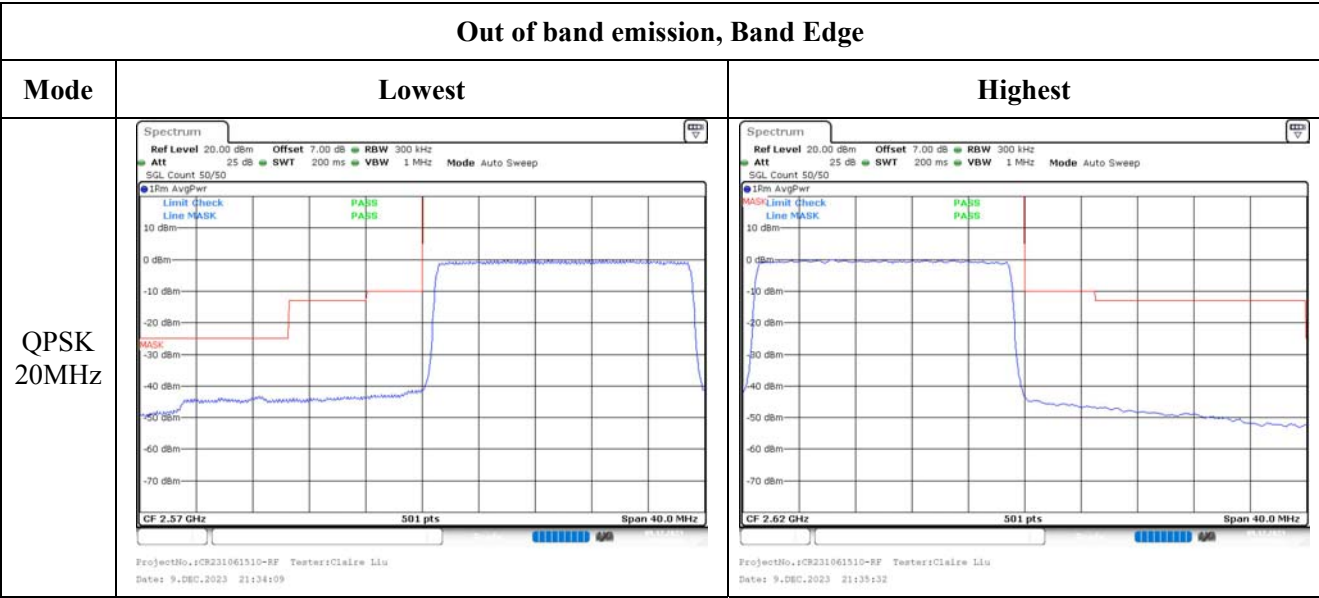


Highest

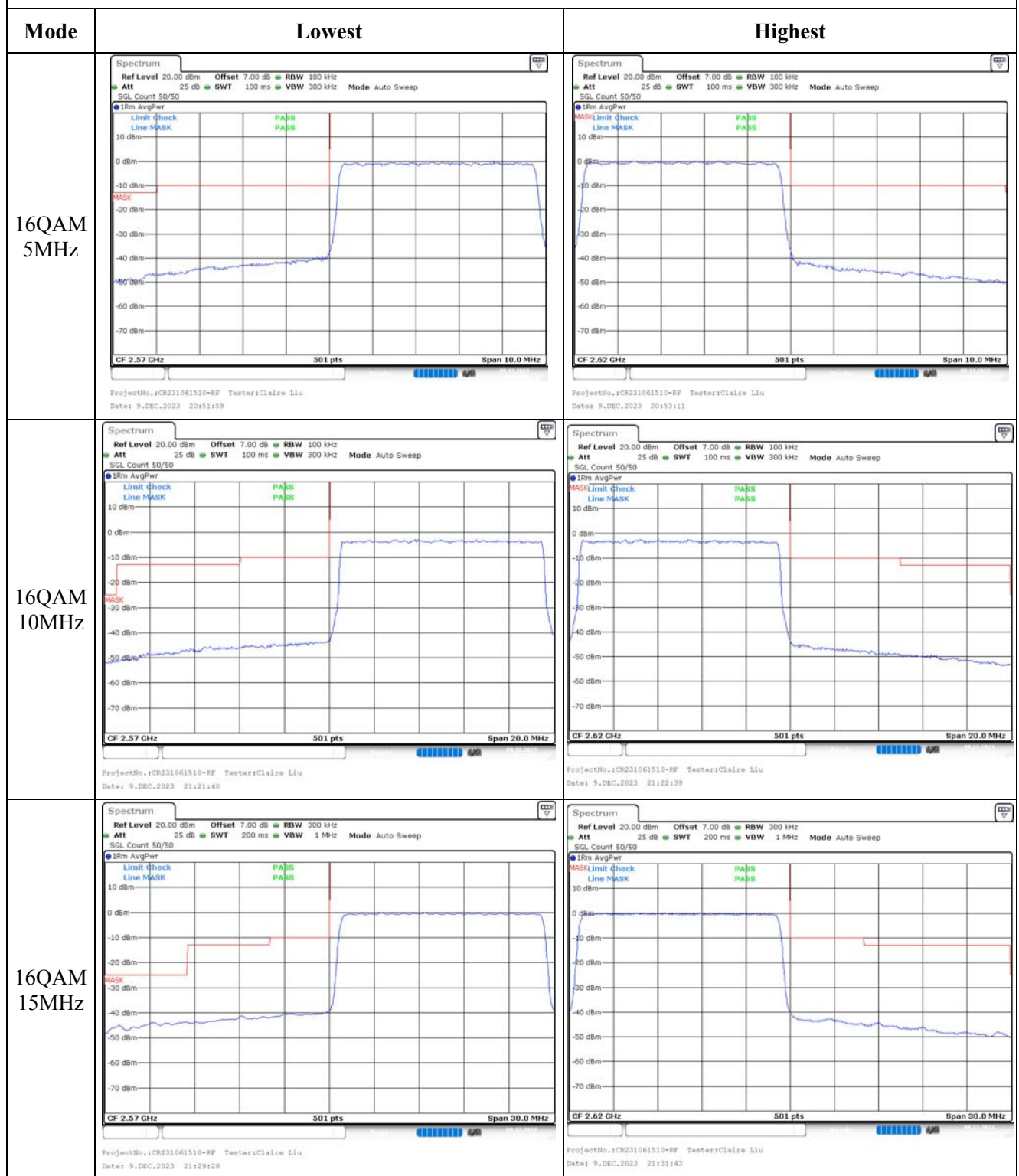


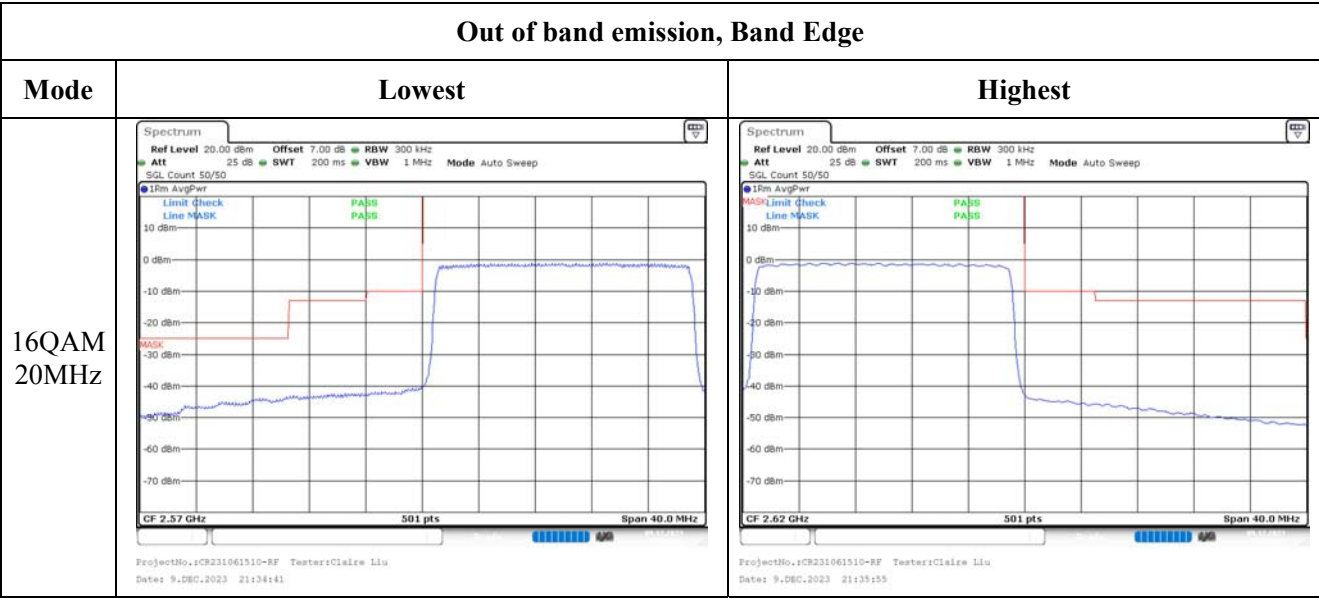
Out of band emission, Band Edge





Out of band emission, Band Edge





4.15 Antenna Port Test Data and Results for LTE Band 40

Serial Number:	2CIM-1	Test Date:	2023/11/12~2023/12/9
Test Site:	RF	Test Mode:	Transmitting
Tester:	Claire Liu	Test Result:	Pass

Environmental Conditions:

Temperature: (°C)	24.7~25.5	Relative Humidity: (%)	53~62	ATM Pressure: (kPa)	100.1~102
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Test Equipment List and Details:

Manufacturer	Description	Model	Serial Number	Calibration Date	Calibration Due Date
R&S	Spectrum Analyzer	FSV40	101590	2022/11/25	2023/11/24
zhuoxiang	Coaxial Cable	SMA-178	211002	Each time	N/A
Minl-Circuits	Power Splitter	ZFRSC-183-S+	S F448201619	Each time	N/A
R&S	Wideband Radio Communication Tester	CMW500	143458	2023/3/31	2024/3/30
BACL	TEMP&HUMI Test Chamber	BTH-150-40	30174	2023/3/31	2024/3/30
UNI-T	Multimeter	UT39A+	C210582554	2023/9/28	2024/9/27
ZHAOXIN	DC Power Supply	RXN-6010D	21R6010D0912386	2023/9/28	2024/9/27
R&S	Spectrum Analyzer	FSV40	101590	2023/11/16	2024/11/15

* Statement of Traceability: China Certification ICT Co., Ltd (Dongguan) attests that all calibrations have been performed, traceable to National Primary Standards and International System of Units (SI).

Test Frequency For Each Mode:

Operation Band	Operation Bandwidth	Lowest Frequency (MHz)	Middle Frequency (MHz)	Highest Frequency (MHz)
LTE Band 40 Lower 2305-2315MHz	5MHz	2307.5	/	2312.5
	10MHz	/	2310	/
LTE Band 40 Upper 2350-2360MHz	5MHz	2352.5	/	2357.5
	10MHz	/	2355	/

Test Data:

(Note: Uplink Downlink configuration 3 was tested)

RF Output Power**LTE Band 40 Lower:**

Test Bandwidth & Modulation	Resource Block & RB offset	Conducted Average Output Power(dBm)			Maximum EIRP (dBm)	Limit (dBm)
		Lowest Channel	Middle Channel	Highest Channel		
5MHz QPSK	RB1#0	21.28	/	21.26	20.06	24
	RB1#13	21.4	/	21.39		
	RB1#24	21.29	/	21.27		
	RB15#0	20.28	/	20.29		
	RB15#10	20.29	/	20.32		
	RB25#0	20.3	/	20.3		
5MHz 16QAM	RB1#0	20.54	/	20.36	19.33	24
	RB1#13	20.67	/	20.49		
	RB1#24	20.56	/	20.36		
	RB15#0	19.32	/	19.28		
	RB15#10	19.38	/	19.37		
	RB25#0	19.32		19.36		
10MHz QPSK	RB1#0	/	21.34	/	20.05	24
	RB1#25	/	21.38	/		
	RB1#49	/	21.39	/		
	RB25#0	/	20.22	/		
	RB25#25	/	20.33	/		
	RB50#0	/	20.29	/		
10MHz 16QAM	RB1#0	/	20.26	/	18.99	24
	RB1#25	/	20.33	/		
	RB1#49	/	20.3	/		
	RB25#0	/	19.32	/		
	RB25#25	/	19.41	/		
	RB50#0	/	19.32	/		

EIRP PSD in 5MHz:

Test Bandwidth & Modulation	Resource Block & RB offset	Conducted PSD(dBm/5MHz)			Maximum EIRP PSD (dBm/5MHz)	Limit (dBm/5MHz)
		Lowest Channel	Middle Channel	Highest Channel		
10MHz QPSK	RB1#0	/	20.14	/	18.96	24
	RB1#25	/	20.30	/		
	RB1#49	/	20.28	/		
	RB25#0	/	18.10	/		
	RB25#25	/	18.20	/		
	RB50#0	/	16.62	/		
10MHz 16QAM	RB1#0	/	20.05	/	18.79	24
	RB1#25	/	20.11	/		
	RB1#49	/	20.13	/		

	RB25#0	/	17.30	/		
	RB25#25	/	17.42	/		
	RB50#0	/	15.66	/		

Note:

For 5MHz mode, the channel power is equal to the test result in dBm/5MHz.

EIRP=Conducted Power(dBm) - Lc(dB) + G_T(dBi)EIRP PSD=Conducted PSD(dBm/5MHz) - Lc(dB) + G_T(dBi)**LTE Band 40 Upper:**

Test Bandwidth & Modulation	Resource Block & RB offset	Conducted Average Output Power(dBm)			Maximum EIRP (dBm)	EIRP Limit (dBm)
		Lowest Channel	Middle Channel	Highest Channel		
5MHz QPSK	RB1#0	21.33	/	21.27	20.09	24
	RB1#13	21.43	/	21.41		
	RB1#24	21.33	/	21.30		
	RB15#0	20.29	/	20.31		
	RB15#10	20.35	/	20.36		
	RB25#0	20.31	/	20.31		
5MHz 16QAM	RB1#0	20.56	/	20.37	19.37	24
	RB1#13	20.71	/	20.54		
	RB1#24	20.62	/	20.40		
	RB15#0	19.37	/	19.33		
	RB15#10	19.38	/	19.38		
	RB25#0	19.34	/	19.42		
10MHz QPSK	RB1#0	/	21.36	/	20.10	24
	RB1#25	/	21.44	/		
	RB1#49	/	21.40	/		
	RB25#0	/	20.32	/		
	RB25#25	/	20.41	/		
	RB50#0	/	20.39	/		
10MHz 16QAM	RB1#0	/	20.61	/	19.34	24
	RB1#25	/	20.66	/		
	RB1#49	/	20.68	/		
	RB25#0	/	19.34	/		
	RB25#25	/	19.44	/		
	RB50#0	/	19.40	/		

EIRP PSD in 5MHz:

Test Bandwidth & Modulation	Resource Block & RB offset	Conducted PSD(dBm/5MHz)			Maximum EIRP PSD (dBm/5MHz)	Limit (dBm/5MHz)
		Lowest Channel	Middle Channel	Highest Channel		
10MHz QPSK	RB1#0	/	20.21	/	18.87	24
	RB1#25	/	20.21	/		
	RB1#49	/	20.18	/		
	RB25#0	/	18.10	/		
	RB25#25	/	18.20	/		
	RB50#0	/	16.63	/		

10MHz 16QAM	RB1#0	/	19.76	/	18.54	24
	RB1#25	/	19.88	/		
	RB1#49	/	19.79	/		
	RB25#0	/	17.33	/		
	RB25#25	/	17.38	/		
	RB50#0	/	15.76	/		
Note: For 5MHz mode, the channel power is equal to the test result in dBm/5MHz. EIRP=Conducted Power(dBm) - Lc(dB) + Gt(dBi) EIRP PSD=Conducted PSD(dBm/5MHz) - Lc(dB) + Gt(dBi)						

Result:**Pass****Duty Cycle**

Operation Band	Modulation	Bandwidth	Ton (ms)	Ton+off (ms)	Duty Cycle (%)	Limit (%)
LTE Band 40 Lower	QPSK	5M	3	10.05	29.85	38
		10M	3	10.05	29.85	38
	16QAM	5M	3	10.05	29.85	38
		10M	3	10.05	29.85	38
LTE Band 40 Upper	QPSK	5M	3	10.05	29.85	38
		10M	3	10.05	29.85	38
	16QAM	5M	3	10.05	29.85	38
		10M	3	10.05	29.85	38
					Result:	Pass

Occupied Bandwidth**LTE Band 40 Lower:**

Operation Mode	99% Occupied Bandwidth (MHz)			26 dB Occupied Bandwidth (MHz)		
	Low Channel	Middle channel	High Channel	Low Channel	Middle channel	High Channel
5MHz QPSK	4.511	/	4.491	5.04	/	5.08
5MHz 16QAM	4.491	/	4.511	4.94	/	4.96
10MHz QPSK	/	8.942	/	/	9.64	/
10MHz 16QAM	/	8.942	/	/	9.56	/

LTE Band 40 Upper:

Operation Mode	99% Occupied Bandwidth (MHz)			26 dB Occupied Bandwidth (MHz)		
	Low Channel	Middle channel	High Channel	Low Channel	Middle channel	High Channel
5MHz QPSK	4.511	/	4.491	5.12	/	4.94
5MHz 16QAM	4.511	/	4.511	4.94	/	5
10MHz QPSK	/	8.942	/	/	9.68	/
10MHz 16QAM	/	8.942	/	/	9.52	/

Note: The test plots please refer to the Plots of Occupied Bandwidth

Spurious Emissions at Antenna Terminal

Result:	Pass, Please refer to the test plots of Spurious Emissions at Antenna Terminal.
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Out of band emission, Band Edge

Result:	Pass, Please refer to the test plots of Out of band emission, Band Edge.
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Frequency Stability**LTE Band 40 Lower:**

Test Mode:	10M QPSK	Test Channel: Lowest for Lower Edge,Highest for Upper Edge				
Test Item	Temperature (°C)	Voltage (V _{DC})	Lower Edge (MHz)		Upper Edge (MHz)	
			Result	Limit	Result	Limit
Frequency Stability vs. Temperature	-30	3.91	2305.172	2305.000	2314.754	2315.000
	-20	3.91	2305.190	2305.000	2314.759	2315.000
	-10	3.91	2305.184	2305.000	2314.792	2315.000
	0	3.91	2305.205	2305.000	2314.708	2315.000
	10	3.91	2305.182	2305.000	2314.797	2315.000
	20	3.91	2305.160	2305.000	2314.800	2315.000
	30	3.91	2305.242	2305.000	2314.724	2315.000
	40	3.91	2305.164	2305.000	2314.722	2315.000
	50	3.91	2305.231	2305.000	2314.779	2315.000
Frequency Stability vs. Voltage	20	3.45	2305.178	2305.000	2314.762	2315.000
	20	4.5	2305.254	2305.000	2314.713	2315.000
					Result:	Pass

Test Mode:	10M 16QAM	Test Channel: Lowest for Lower Edge,Highest for Upper Edge				
Test Item	Temperature (°C)	Voltage (V _{DC})	Lower Edge (MHz)		Upper Edge (MHz)	
			Result	Limit	Result	Limit
Frequency Stability vs. Temperature	-30	3.91	2305.256	2305.000	2314.749	2315.000
	-20	3.91	2305.246	2305.000	2314.730	2315.000
	-10	3.91	2305.196	2305.000	2314.799	2315.000
	0	3.91	2305.201	2305.000	2314.704	2315.000
	10	3.91	2305.251	2305.000	2314.788	2315.000
	20	3.91	2305.160	2305.000	2314.800	2315.000
	30	3.91	2305.202	2305.000	2314.764	2315.000
	40	3.91	2305.234	2305.000	2314.764	2315.000
	50	3.91	2305.245	2305.000	2314.725	2315.000
Frequency Stability vs. Voltage	20	3.45	2305.188	2305.000	2314.782	2315.000
	20	4.5	2305.207	2305.000	2314.782	2315.000
					Result:	Pass

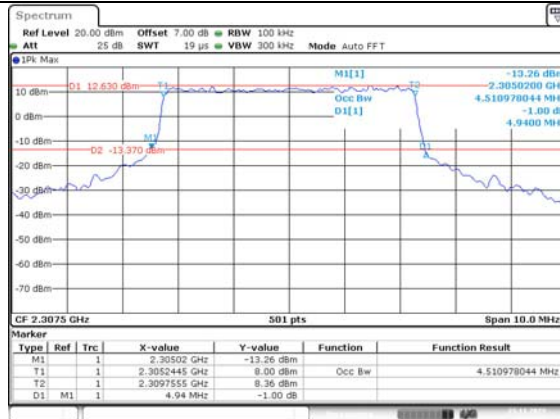
LTE Band 40 Upper:						
Test Mode:	10M QPSK	Test Channel: Lowest for Lower Edge,Highest for Upper Edge				
Test Item	Temperature (°C)	Voltage (V _{DC})	Lower Edge (MHz)		Upper Edge (MHz)	
			Result	Limit	Result	Limit
Frequency Stability vs. Temperature	-30	3.91	2350.239	2350.000	2359.735	2360.000
	-20	3.91	2350.189	2350.000	2359.677	2360.000
	-10	3.91	2350.260	2350.000	2359.712	2360.000
	0	3.91	2350.219	2350.000	2359.730	2360.000
	10	3.91	2350.208	2350.000	2359.694	2360.000
	20	3.91	2350.160	2350.000	2359.760	2360.000
	30	3.91	2350.192	2350.000	2359.744	2360.000
	40	3.91	2350.178	2350.000	2359.671	2360.000
	50	3.91	2350.236	2350.000	2359.683	2360.000
Frequency Stability vs. Voltage	20	3.45	2350.216	2350.000	2359.693	2360.000
	20	4.5	2350.241	2350.000	2359.663	2360.000
					Result:	Pass

Test Mode:	10M 16QAM	Test Channel: Lowest for Lower Edge,Highest for Upper Edge				
Test Item	Temperature (°C)	Voltage (V _{DC})	Lower Edge (MHz)		Upper Edge (MHz)	
			Result	Limit	Result	Limit
Frequency Stability vs. Temperature	-30	3.91	2350.189	2350.000	2359.707	2360.000
	-20	3.91	2350.229	2350.000	2359.745	2360.000
	-10	3.91	2350.208	2350.000	2359.702	2360.000
	0	3.91	2350.236	2350.000	2359.687	2360.000
	10	3.91	2350.245	2350.000	2359.691	2360.000
	20	3.91	2350.160	2350.000	2359.760	2360.000
	30	3.91	2350.199	2350.000	2359.758	2360.000
	40	3.91	2350.197	2350.000	2359.685	2360.000
	50	3.91	2350.215	2350.000	2359.686	2360.000
Frequency Stability vs. Voltage	20	3.45	2350.185	2350.000	2359.683	2360.000
	20	4.5	2350.197	2350.000	2359.661	2360.000
					Result:	Pass

Test Plots (Note: The 7.0 dB is the Insertion loss of the RF cable and Power Splitter, which was offset into the Spectrum Analyzer):
2305-2315 MHz:

Occupied Bandwidth**Channel****5MHz Bandwidth QPSK****5MHz Bandwidth 16QAM**

Lowest

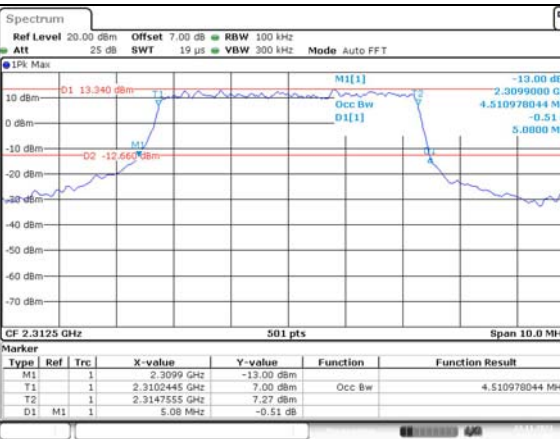


ProjectNo.:CR231061510-RF Tester:Clair Liu
Date: 23.NOV.2023 11:11:12

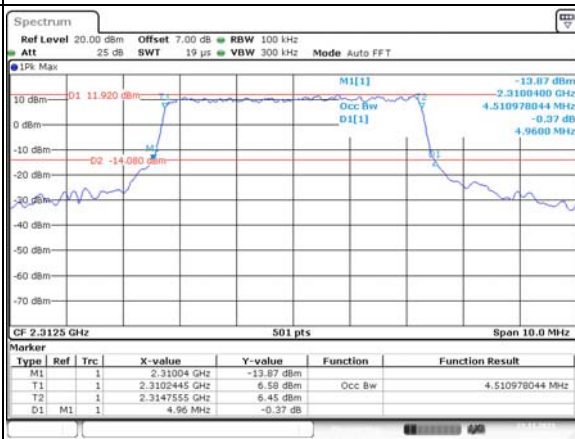


ProjectNo.:CR231061510-RF Tester:Clair Liu
Date: 23.NOV.2023 11:11:16

Highest



ProjectNo.:CR231061510-RF Tester:Clair Liu
Date: 23.NOV.2023 11:12:37



ProjectNo.:CR231061510-RF Tester:Clair Liu
Date: 23.NOV.2023 11:12:55

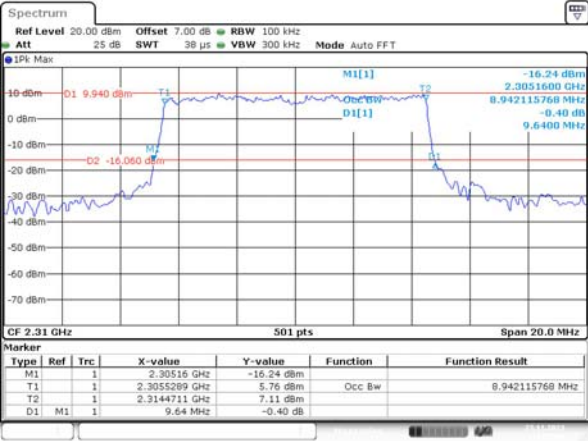
Occupied Bandwidth

Channel

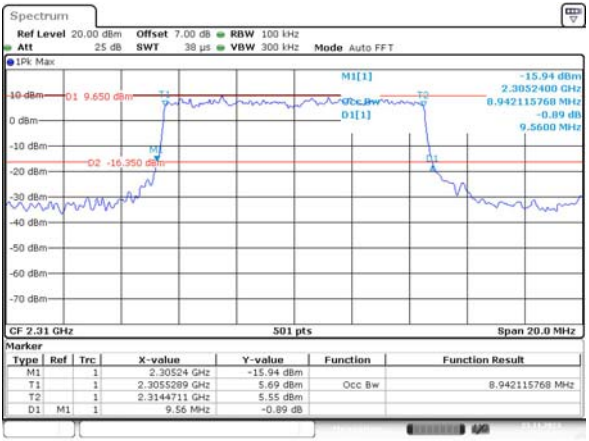
10MHz Bandwidth QPSK

10MHz Bandwidth 16QAM

Middle



ProjectNo.:CR231061510-RF Testers:Claire Liu
Date: 23,NOV,2023 11:13:19



ProjectNo.:CR231061510-RF Testers:Claire Liu
Date: 23,NOV,2023 11:13:46

2350-2360 MHz:

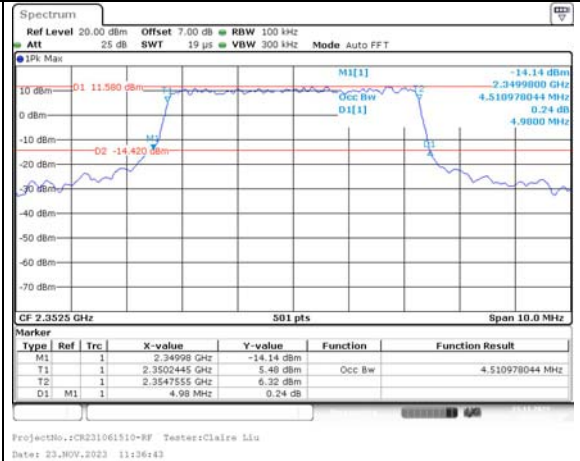
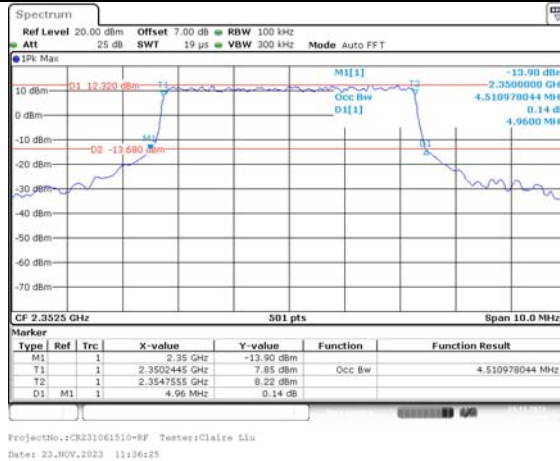
Occupied Bandwidth

Channel

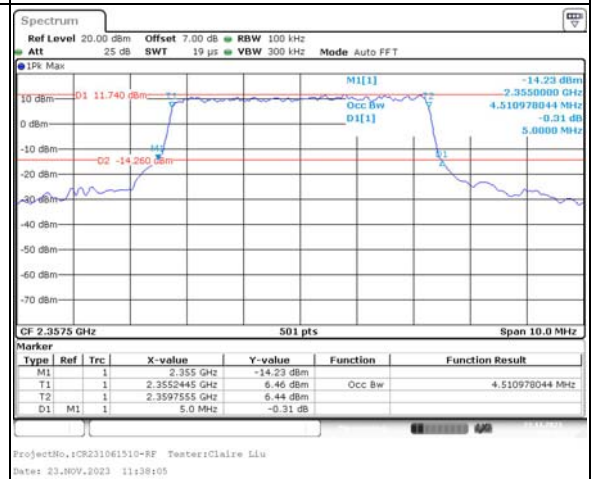
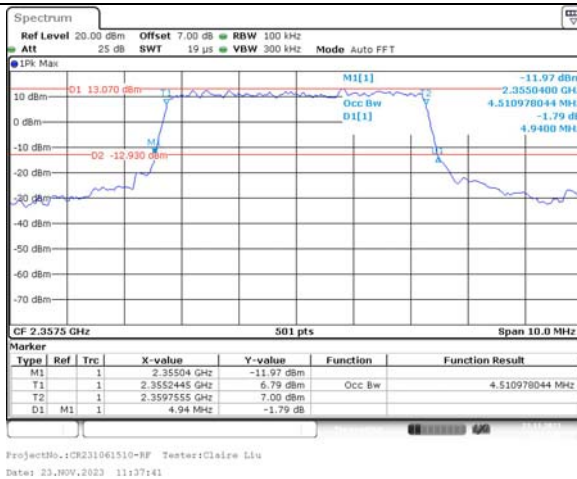
5MHz Bandwidth QPSK

5MHz Bandwidth 16QAM

Lowest



Highest



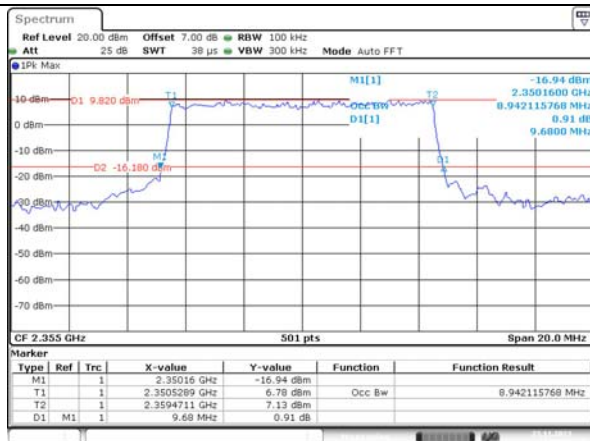
Occupied Bandwidth

Channel

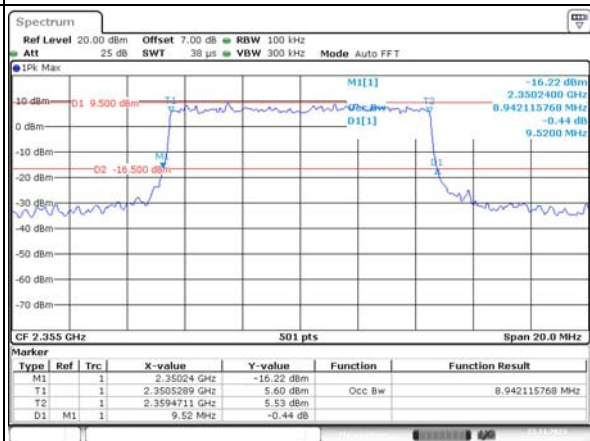
10MHz Bandwidth QPSK

10MHz Bandwidth 16QAM

Middle



ProjectNo.:CR231061510-RF Testers:Claire Liu
Date: 23,NOV,2023 11:38:35



ProjectNo.:CR231061510-RF Testers:Claire Liu
Date: 23,NOV,2023 11:38:53

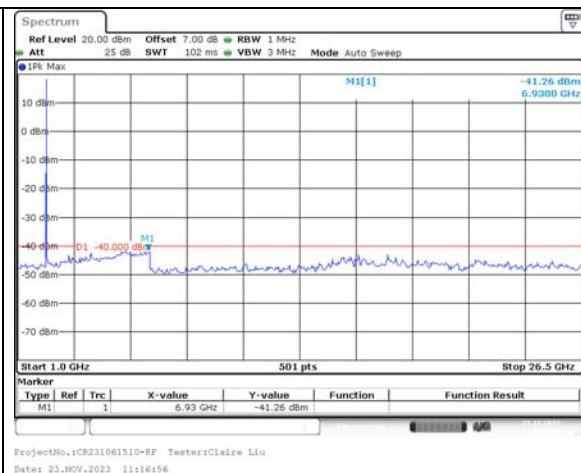
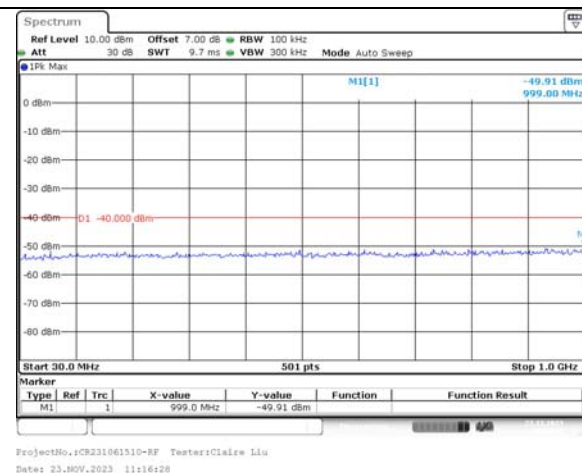
2305-2315 MHz:

Spurious Emissions at Antenna Terminal

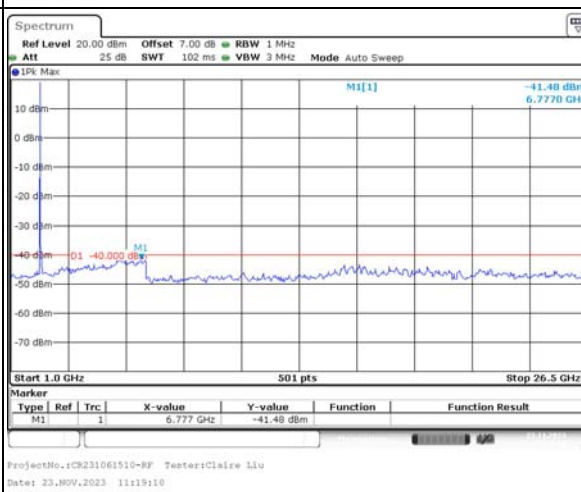
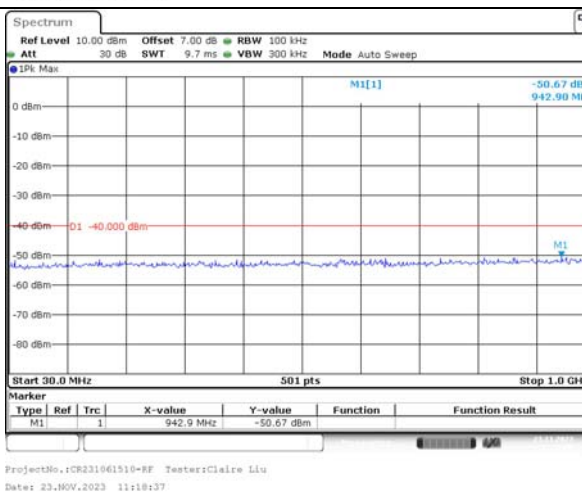
Channel

5MHz Bandwidth QPSK

Lowest



Highest

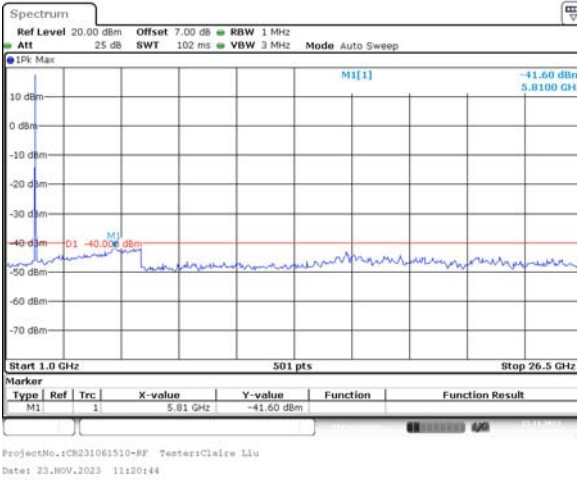
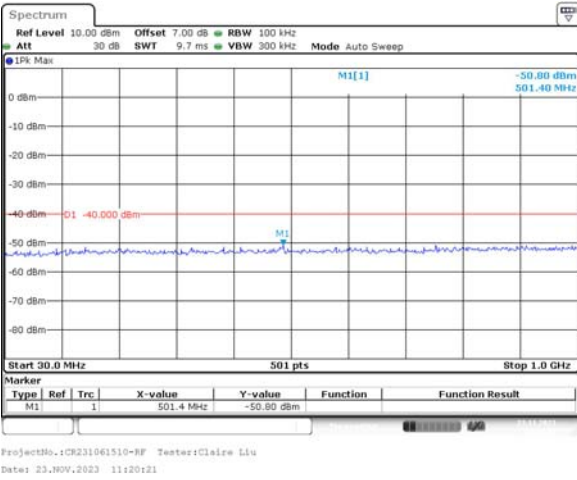


Spurious Emissions at Antenna Terminal

Channel

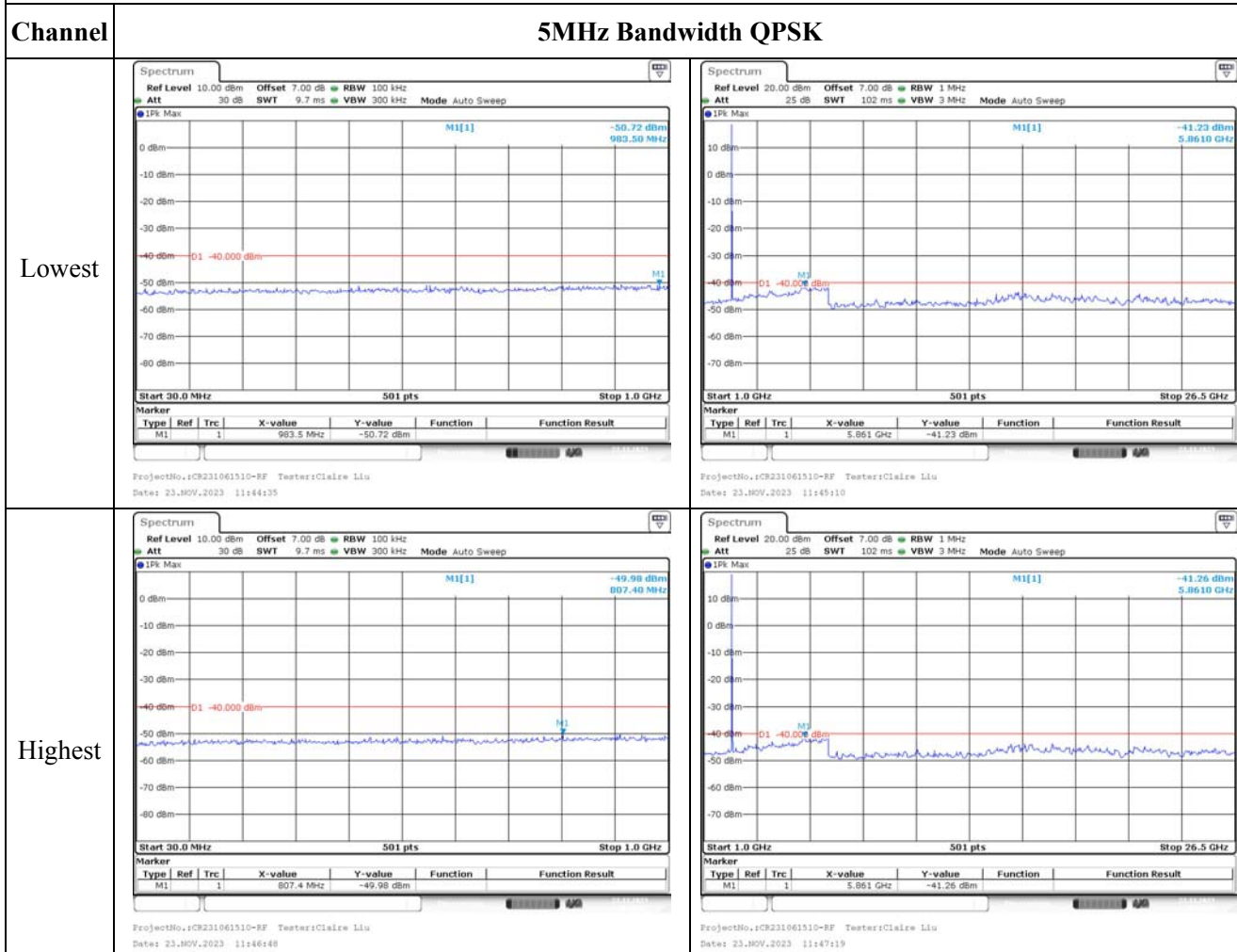
10MHz Bandwidth QPSK

Middle

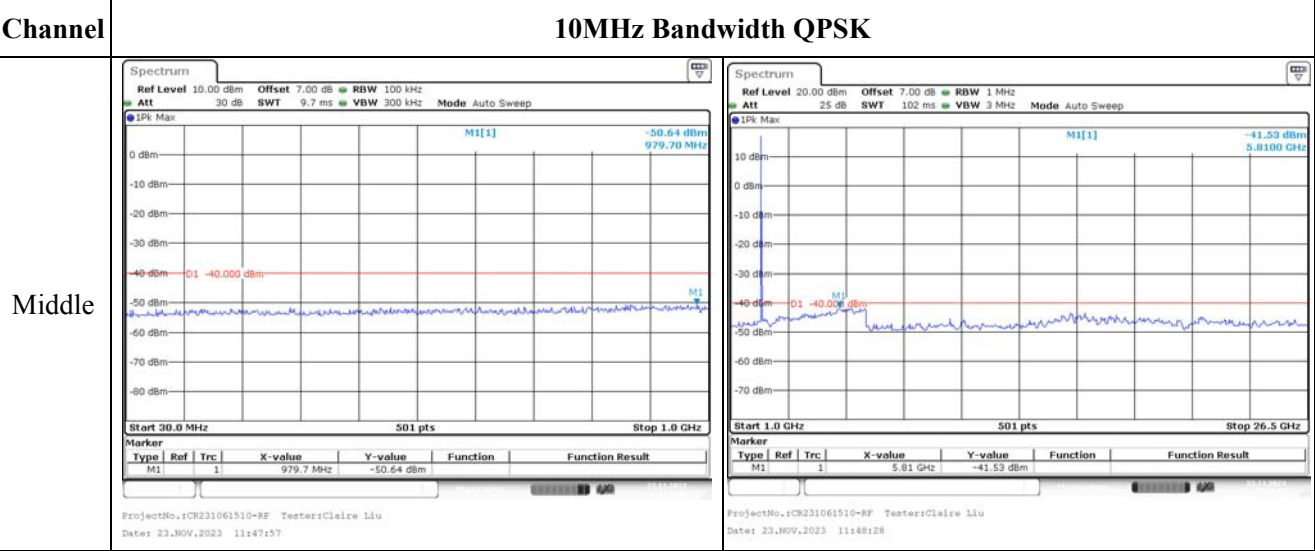


2350-2360 MHz:

Spurious Emissions at Antenna Terminal

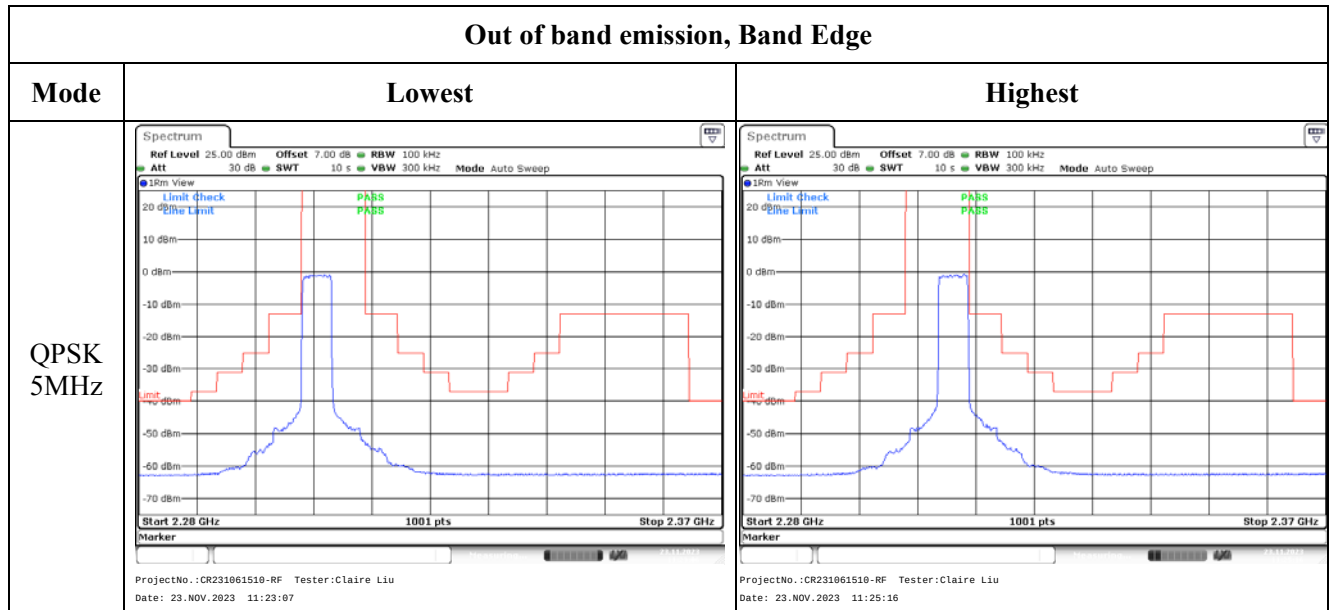


Spurious Emissions at Antenna Terminal

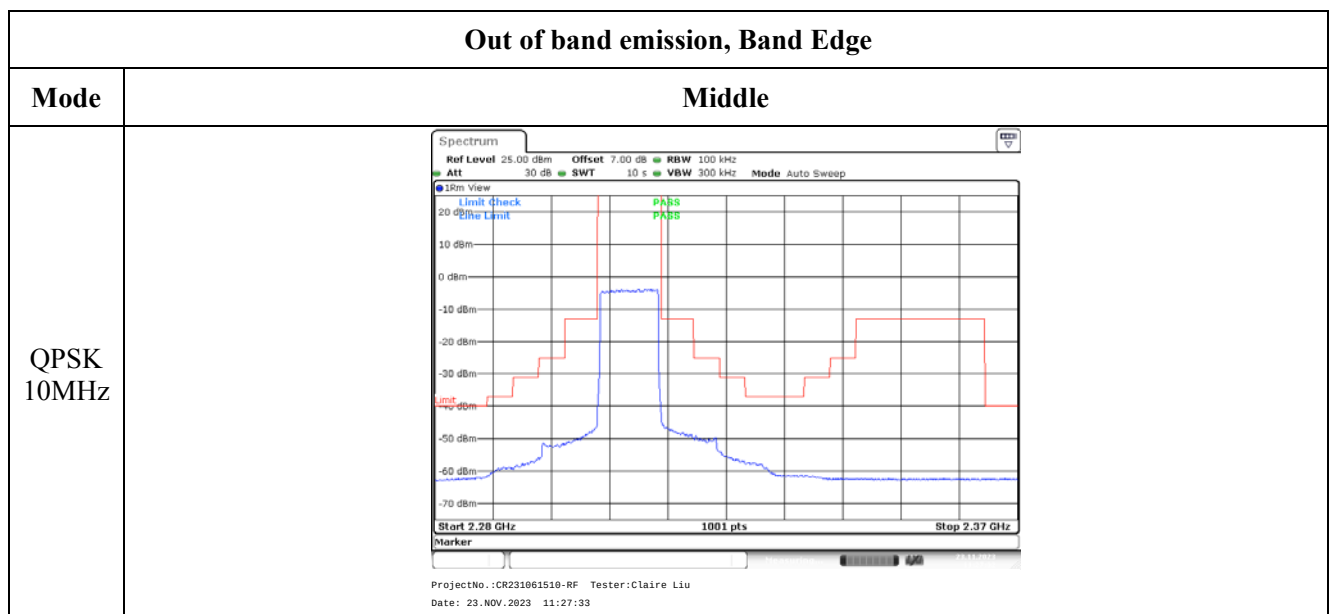


2305-2315 MHz:

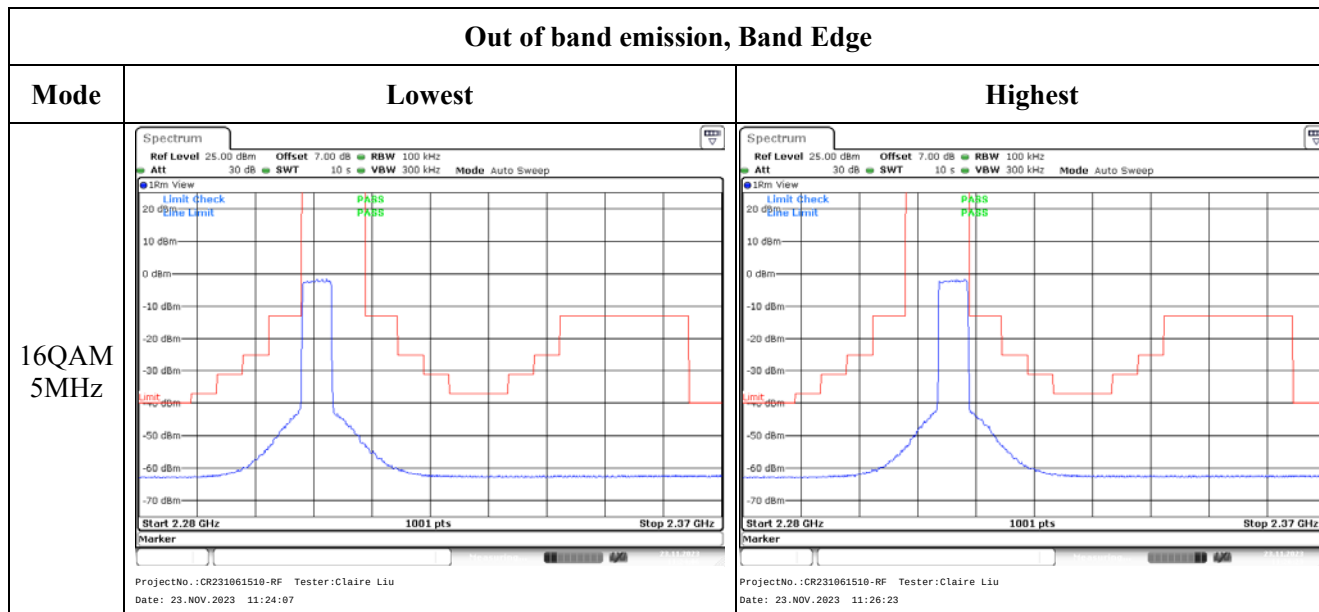
Out of band emission, Band Edge



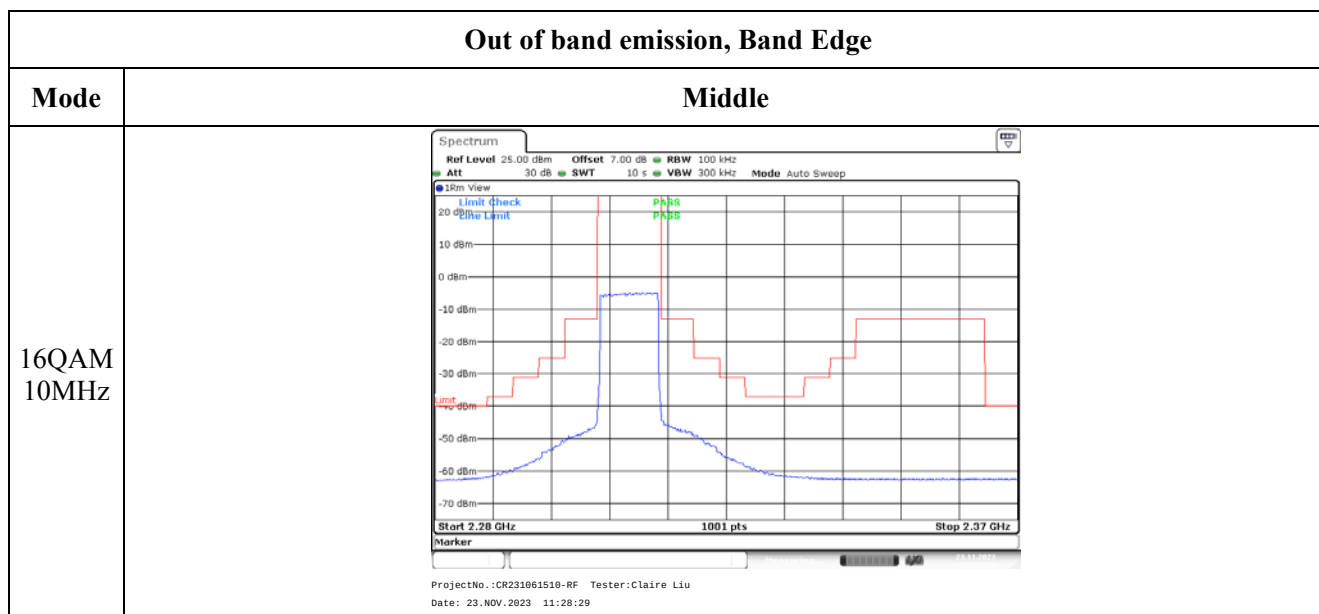
Out of band emission, Band Edge



Out of band emission, Band Edge

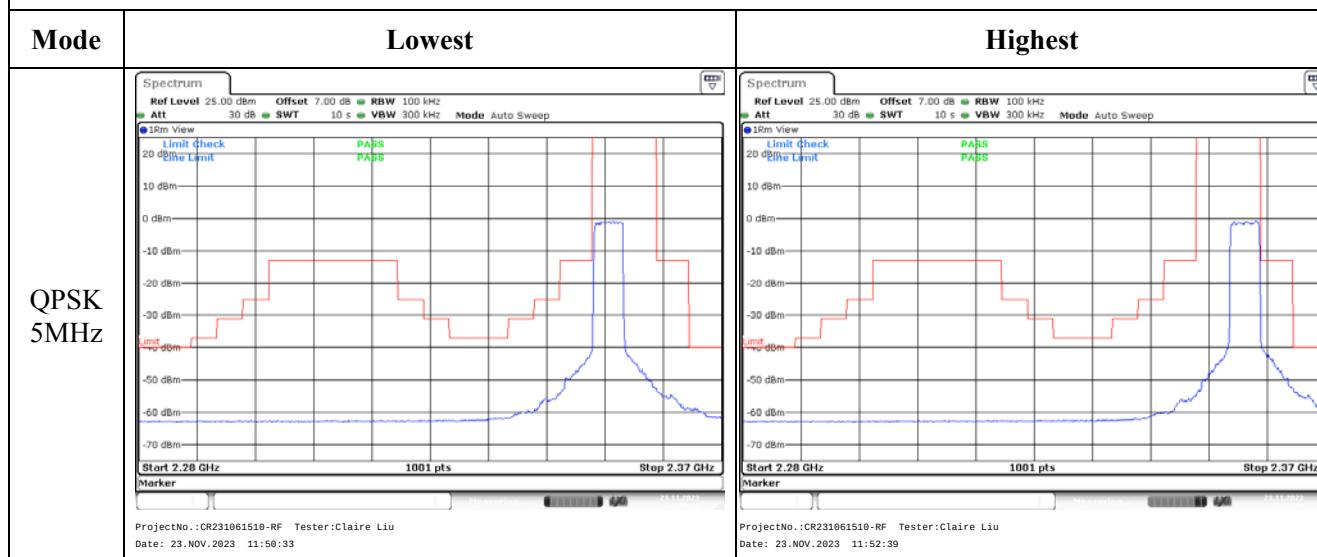


Out of band emission, Band Edge

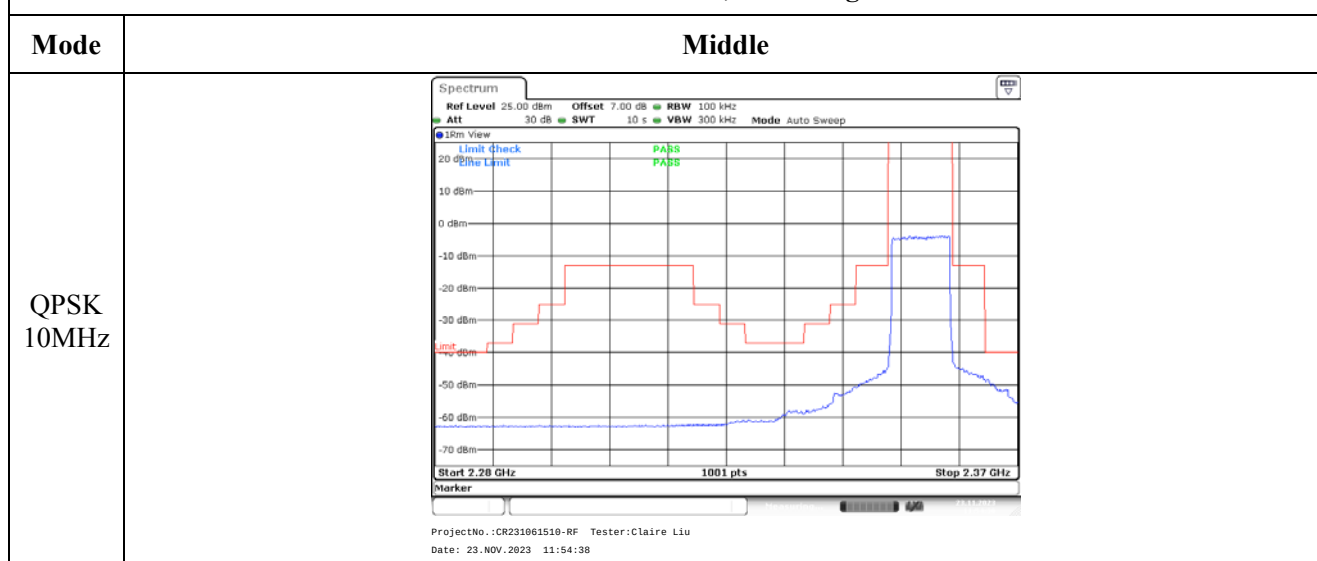


2350-2360 MHz:

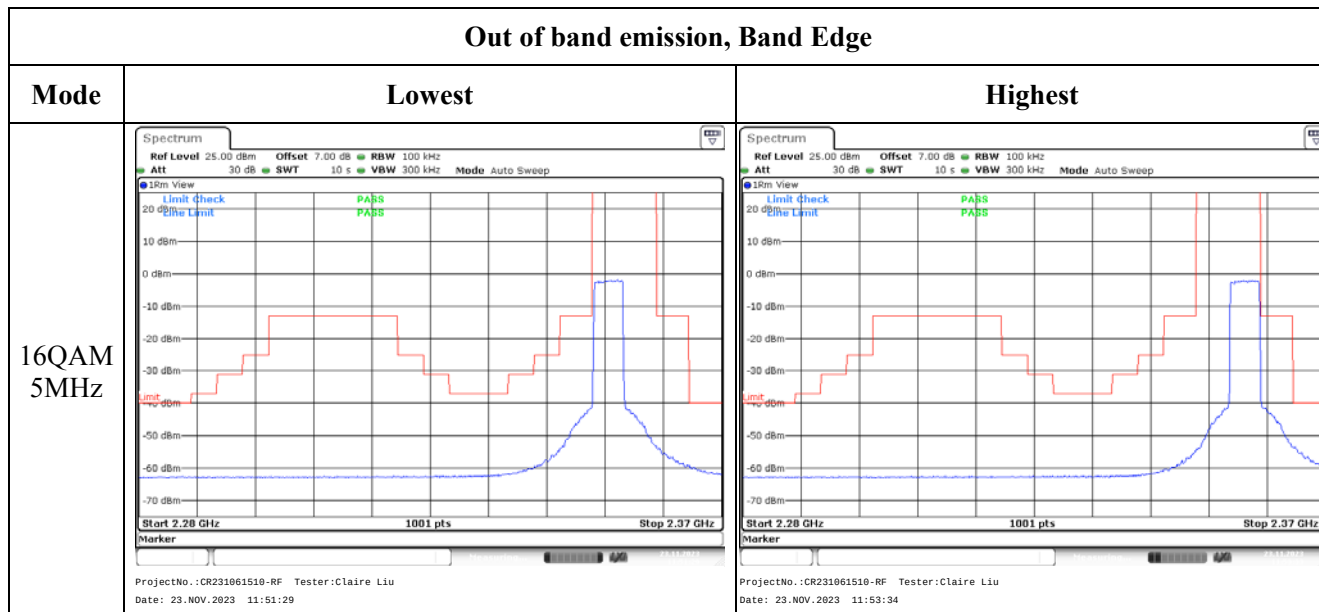
Out of band emission, Band Edge



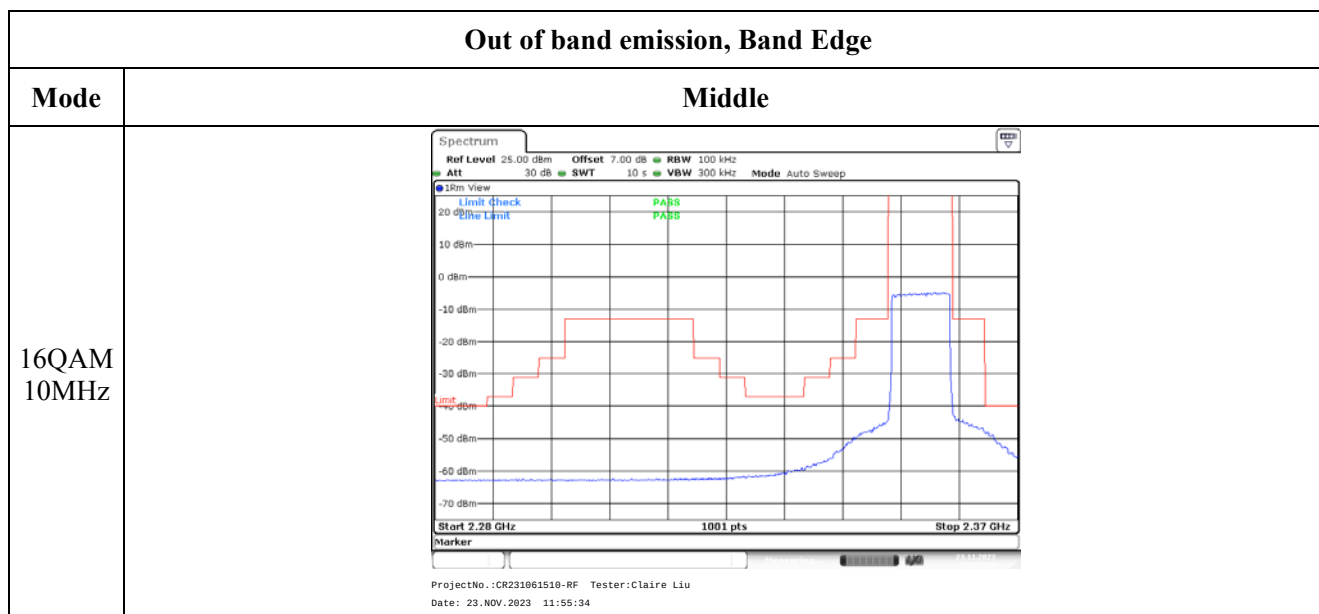
Out of band emission, Band Edge



Out of band emission, Band Edge

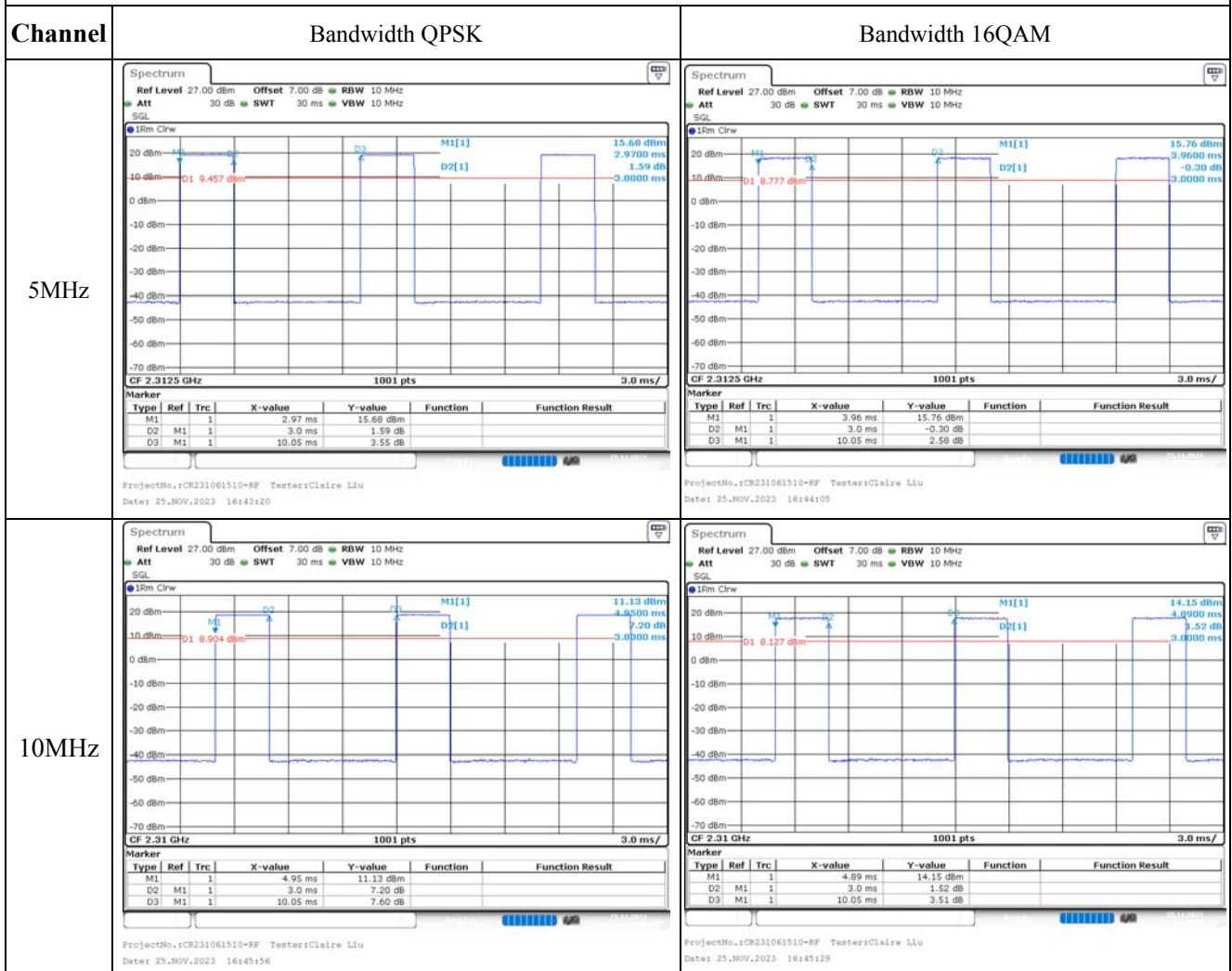


Out of band emission, Band Edge



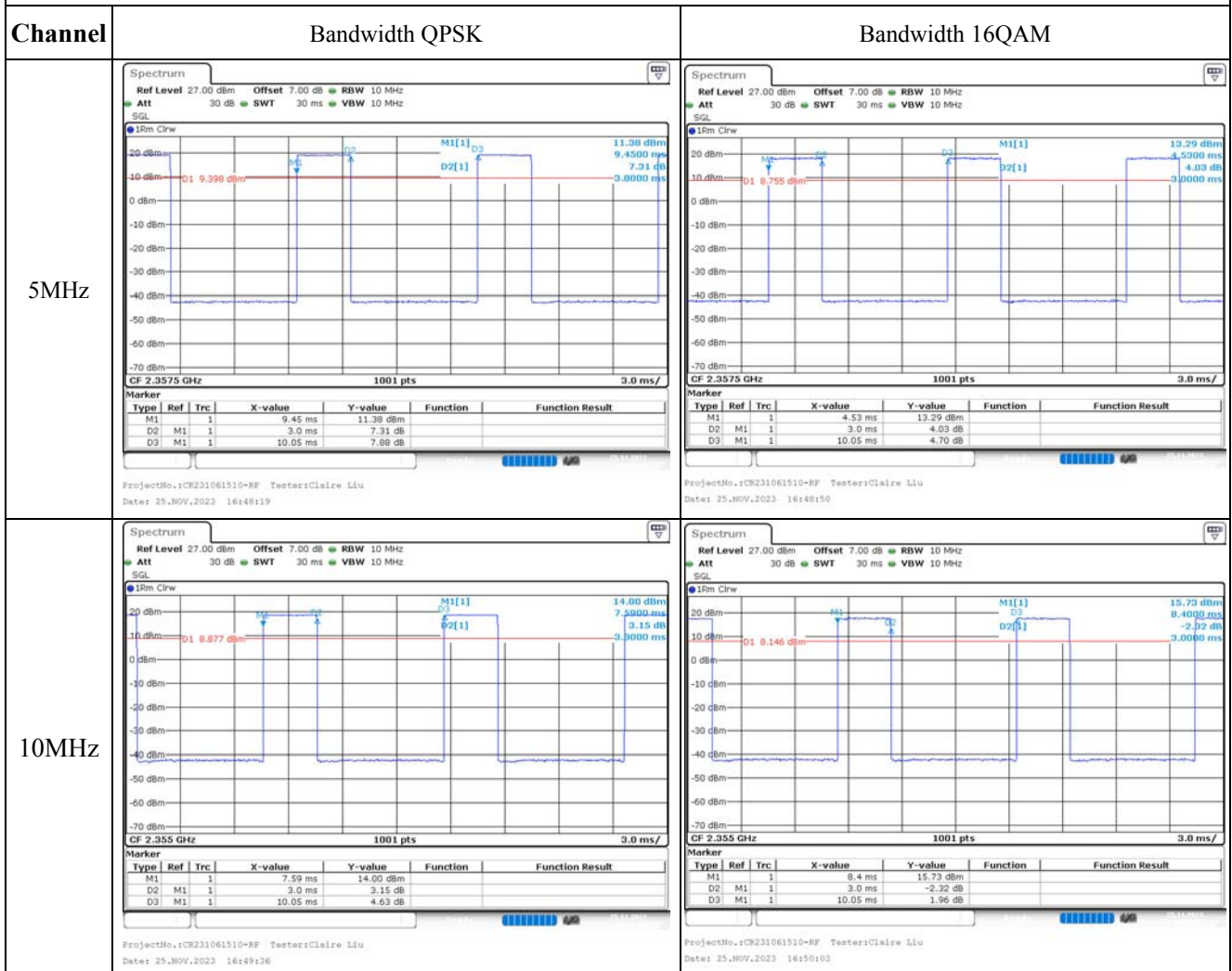
2305-2315 MHz:

Duty Cycle



2350-2360 MHz:

Duty Cycle



4.16 Antenna Port Test Data and Results for LTE Band 41

Serial Number:	2CIM-1	Test Date:	2023/11/12~2024/1/10
Test Site:	RF	Test Mode:	Transmitting
Tester:	Claire Liu	Test Result:	Pass

Environmental Conditions:

Temperature: (°C)	24.7~25.5	Relative Humidity: (%)	53~62	ATM Pressure: (kPa)	100.1~102
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Test Equipment List and Details:

Manufacturer	Description	Model	Serial Number	Calibration Date	Calibration Due Date
R&S	Spectrum Analyzer	FSV40	101590	2022/11/25	2023/11/24
zhuoxiang	Coaxial Cable	SMA-178	211002	Each time	N/A
Minl-Clrucits	Power Splitter	ZFRSC-183-S+	S F448201619	Each time	N/A
R&S	Wideband Radio Communication Tester	CMW500	143458	2023/3/31	2024/3/30
BACL	TEMP&HUMI Test Chamber	BTH-150-40	30174	2023/3/31	2024/3/30
UNI-T	Multimeter	UT39A+	C210582554	2023/9/28	2024/9/27
ZHAOXIN	DC Power Supply	RXN-6010D	21R6010D0912386	2023/9/28	2024/9/27
R&S	Spectrum Analyzer	FSV40	101590	2023/11/16	2024/11/15

* Statement of Traceability: China Certification ICT Co., Ltd (Dongguan) attests that all calibrations have been performed, traceable to National Primary Standards and International System of Units (SI).

Test Frequency For Each Mode:

Operation Bandwidth	Lowest Frequency (MHz)	Middle Frequency (MHz)	Highest Frequency (MHz)
5MHz	2537.5	2595	2652.5
10MHz	2540	2595	2650
15MHz	2542.5	2595	2647.5
20MHz	2545	2595	2645

Test Data:**RF Output Power**

Test Bandwidth & Modulation	Resource Block & RB offset	Conducted Average Output Power(dBm)			Maximum EIRP (dBm)	EIRP Limit (dBm)
		Lowest Channel	Middle Channel	Highest Channel		
5MHz QPSK	RB1#0	19.3	19.09	19.46	18.75	33
	RB1#13	19.42	19.21	19.63		
	RB1#24	19.29	19.1	19.56		
	RB15#0	18.26	18.1	18.57		
	RB15#10	18.3	18.15	18.59		
	RB25#0	18.29	18.12	18.52		
5MHz 16QAM	RB1#0	18.55	18.08	18.55	17.81	33
	RB1#13	18.66	18.22	18.69		
	RB1#24	18.59	18.14	18.62		
	RB15#0	17.34	17.1	17.59		
	RB15#10	17.44	17.13	17.64		
	RB25#0	17.35	17.25	17.65		
10MHz QPSK	RB1#0	19.39	19.1	19.54	18.8	33
	RB1#25	19.42	19.22	19.63		
	RB1#49	19.33	19.21	19.68		
	RB25#0	18.22	18.09	18.51		
	RB25#25	18.34	18.18	18.54		
	RB50#0	18.28	18.15	18.55		
10MHz 16QAM	RB1#0	18.48	18.39	18.45	17.69	33
	RB1#25	18.55	18.45	18.53		
	RB1#49	18.44	18.42	18.57		
	RB25#0	17.33	17.17	17.63		
	RB25#25	17.42	17.21	17.63		
	RB50#0	17.36	17.21	17.61		
15MHz QPSK	RB1#0	19.3	19.09	19.45	18.79	33
	RB1#38	19.39	19.25	19.67		
	RB1#74	19.26	19.2	19.65		
	RB36#0	18.17	18.04	18.42		
	RB36#39	18.21	18.13	18.57		
	RB75#0	18.21	18.1	18.52		
15MHz 16QAM	RB1#0	18.53	18.27	18.34	17.72	33
	RB1#38	18.6	18.45	18.6		
	RB1#74	18.49	18.43	18.56		
	RB36#0	17.33	17.06	17.46		
	RB36#39	17.38	17.18	17.56		
	RB75#0	17.28	17.08	17.57		
20MHz QPSK	RB1#0	19.14	19.08	19.28	18.74	33
	RB1#50	19.31	19.33	19.62		
	RB1#99	19.13	19.23	19.57		
	RB50#0	18.12	18.05	18.45		

20MHz 16QAM	RB50#50	18.27	18.15	18.51	17.81	33
	RB100#0	18.21	18.13	18.49		
	RB1#0	18.13	18.3	18.33		
	RB1#50	18.35	18.54	18.69		
	RB1#99	18.11	18.47	18.62		
	RB50#0	17.22	17.14	17.48		
	RB50#50	17.38	17.22	17.53		
	RB100#0	17.28	17.17	17.48		

Note: EIRP=Conducted Power(dBm) - Lc(dB) + G_T(dBi)

Result: **Pass**

Peak-to-average Ratio(PAR)

Test Bandwidth & Modulation	Resource Block & RB offset	Peak-to-average Ratio(dB)			Limit (dB)
		Lowest Channel	Middle Channel	Highest Channel	
20MHz QPSK	RB1#0	9.04	9.19	9.62	13
	RB100#0	8.35	8.38	8.26	13
20MHz 16QAM	RB1#0	10	10.29	10.2	13
	RB100#0	9.91	9.88	9.8	13

Result: **Pass**

Occupied Bandwidth

Operation Mode	99% Occupied Bandwidth (MHz)			26 dB Occupied Bandwidth (MHz)		
	Low Channel	Middle channel	High Channel	Low Channel	Middle Channel	High Channel
5MHz QPSK	4.511	4.96	4.511	5.04	4.511	4.94
5MHz 16QAM	4.511	5	4.511	4.94	4.511	4.96
10MHz QPSK	8.942	9.64	8.942	9.72	8.942	9.56
10MHz 16QAM	8.942	9.52	8.942	9.56	8.942	9.88
15MHz QPSK	13.473	14.76	13.413	14.7	13.413	14.7
15MHz 16QAM	13.473	14.82	13.473	14.82	13.473	14.7
20MHz QPSK	17.884	19.28	17.964	19.28	17.964	19.2
20MHz 16QAM	17.884	19.12	17.884	19.28	17.884	19.28

Note: The test plots please refer to the Plots of Occupied Bandwidth

Spurious Emissions at Antenna Terminal

Result:	Pass, Please refer to the test plots of Spurious Emissions at Antenna Terminal.
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Out of band emission, Band Edge

Result:	Pass, Please refer to the test plots of Out of band emission, Band Edge.
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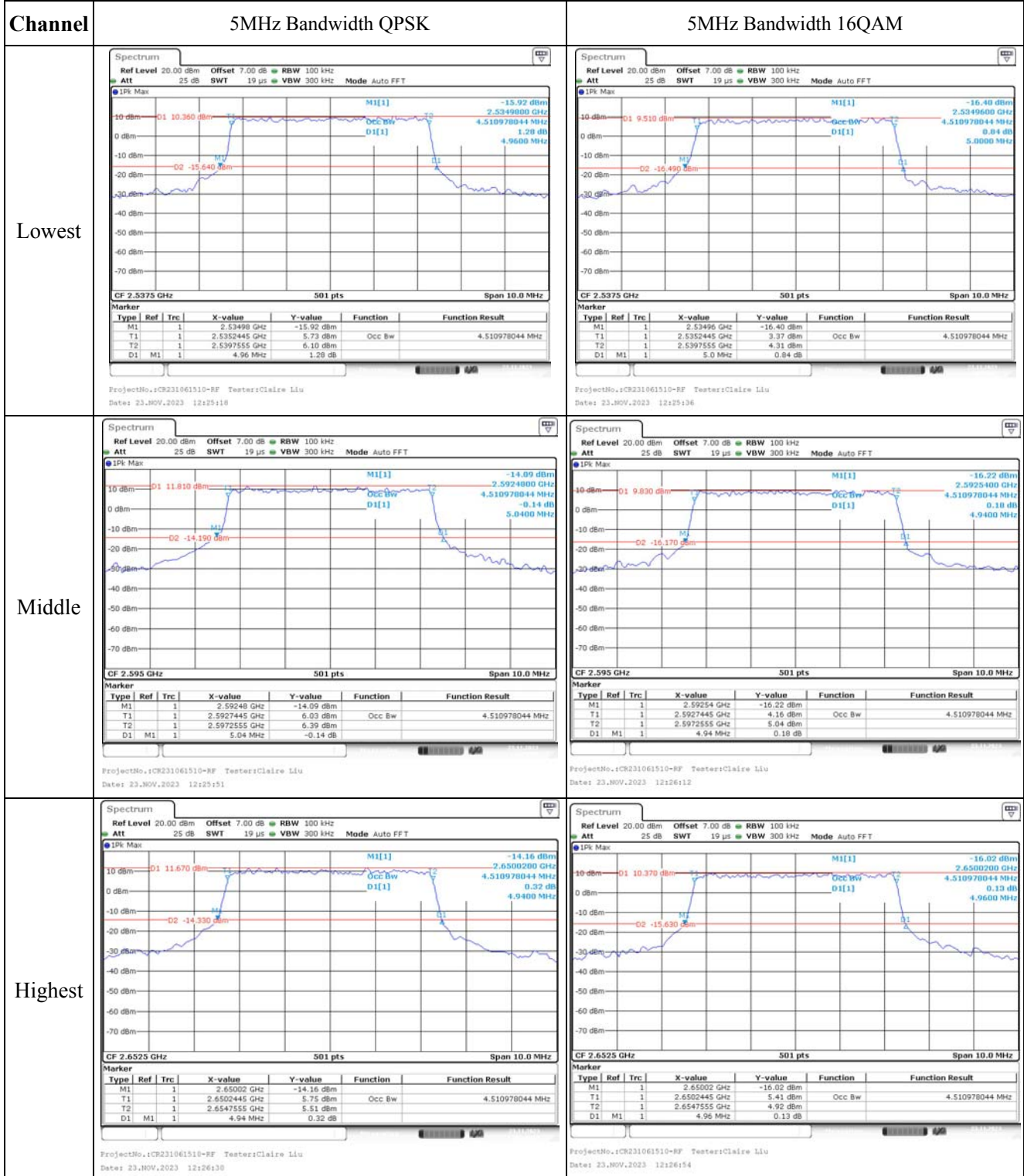
Frequency Stability

Test Mode:	20M QPSK	Test Channel: Lowest for Lower Edge,Highest for Upper Edge				
Test Item	Temperature (°C)	Voltage (V _{DC})	Lower Edge (MHz)		Upper Edge (MHz)	
			Result	Limit	Result	Limit
Frequency Stability vs. Temperature	-30	3.91	2535.484	2535.00	2654.532	2655
	-20	3.91	2535.438	2535.00	2654.557	2655
	-10	3.91	2535.450	2535.00	2654.538	2655
	0	3.91	2535.457	2535.00	2654.513	2655
	10	3.91	2535.498	2535.00	2654.572	2655
	20	3.91	2535.400	2535.00	2654.600	2655
	30	3.91	2535.402	2535.00	2654.595	2655
	40	3.91	2535.429	2535.00	2654.521	2655
	50	3.91	2535.418	2535.00	2654.554	2655
Frequency Stability vs. Voltage	20	3.45	2535.481	2535.00	2654.554	2655
	20	4.5	2535.432	2535.00	2654.554	2655
					Result:	Pass

Test Mode:	20M 16QAM	Test Channel: Lowest for Lower Edge,Highest for Upper Edge				
Test Item	Temperature (°C)	Voltage (V _{DC})	Lower Edge (MHz)		Upper Edge (MHz)	
			Result	Limit	Result	Limit
Frequency Stability vs. Temperature	-30	3.91	2535.530	2535.00	2654.642	2655
	-20	3.91	2535.521	2535.00	2654.603	2655
	-10	3.91	2535.565	2535.00	2654.583	2655
	0	3.91	2535.510	2535.00	2654.642	2655
	10	3.91	2535.553	2535.00	2654.654	2655
	20	3.91	2535.480	2535.00	2654.680	2655
	30	3.91	2535.568	2535.00	2654.674	2655
	40	3.91	2535.509	2535.00	2654.623	2655
	50	3.91	2535.533	2535.00	2654.665	2655
Frequency Stability vs. Voltage	20	3.45	2535.578	2535.00	2654.635	2655
	20	4.5	2535.550	2535.00	2654.622	2655
					Result:	Pass

Test Plots(Note: The 7.0dB is the Insertion loss of the RF cable, Power Splitter and DC Block, which was offset into the Spectrum Analyzer):

Occupied Bandwidth



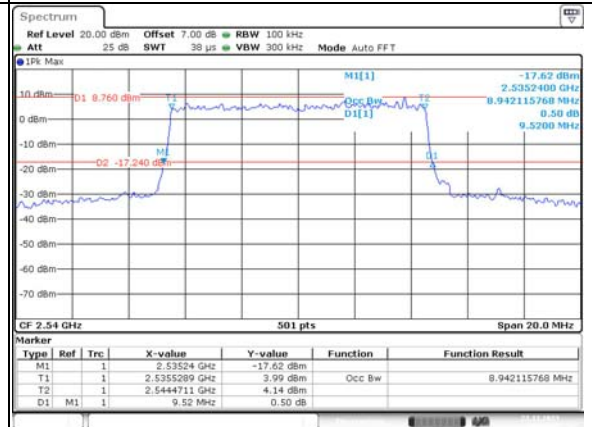
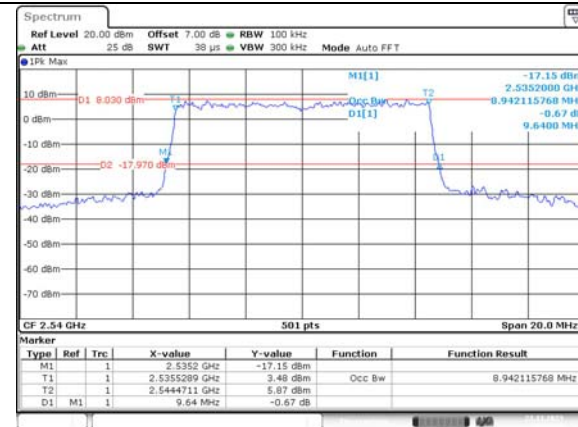
Occupied Bandwidth

Channel

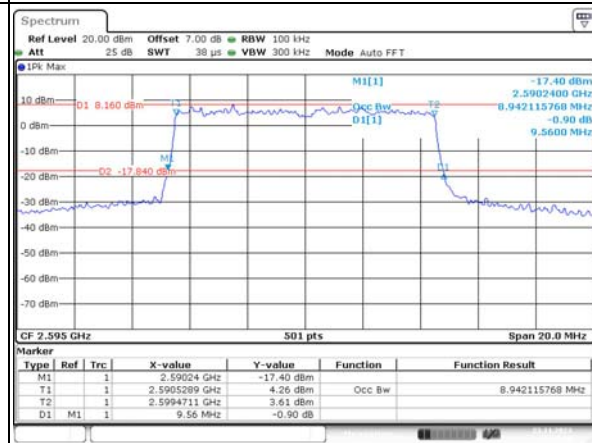
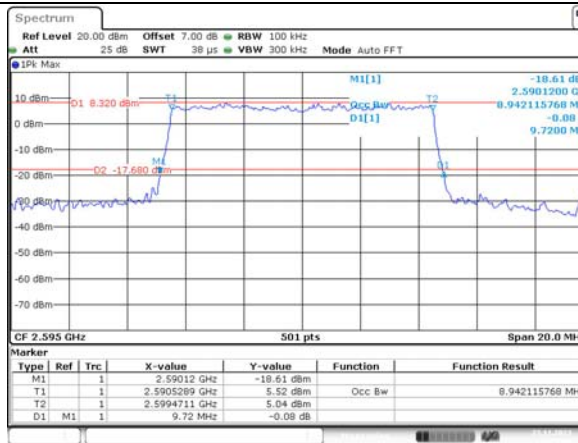
10MHz Bandwidth QPSK

10MHz Bandwidth 16QAM

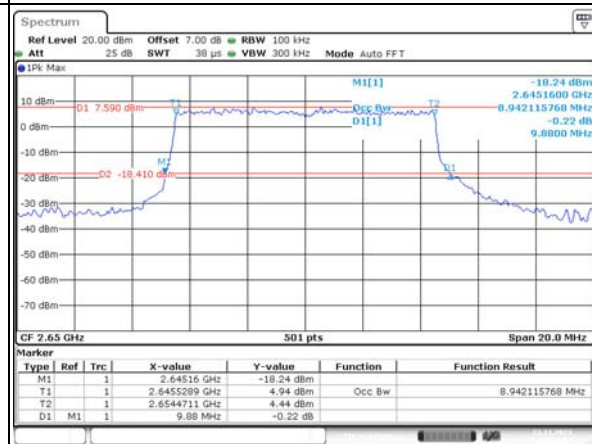
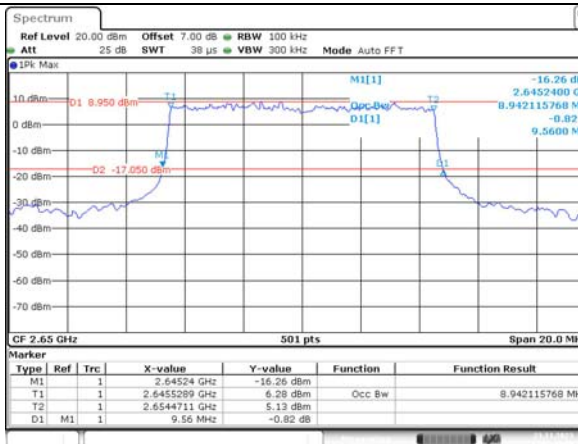
Lowest

ProjectNo.:CR231061510-RF Testers:Claire Liu
Date: 23.NOV.2023 12:29:04ProjectNo.:CR231061510-RF Testers:Claire Liu
Date: 23.NOV.2023 12:29:28

Middle

ProjectNo.:CR231061510-RF Testers:Claire Liu
Date: 23.NOV.2023 12:30:53ProjectNo.:CR231061510-RF Testers:Claire Liu
Date: 23.NOV.2023 12:30:17

Highest

ProjectNo.:CR231061510-RF Testers:Claire Liu
Date: 23.NOV.2023 12:30:38ProjectNo.:CR231061510-RF Testers:Claire Liu
Date: 23.NOV.2023 12:31:02

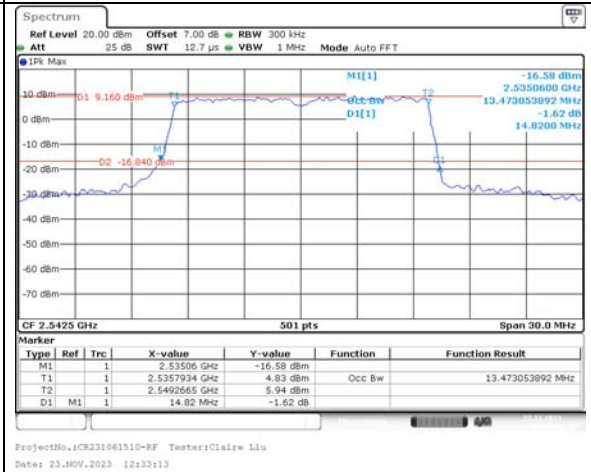
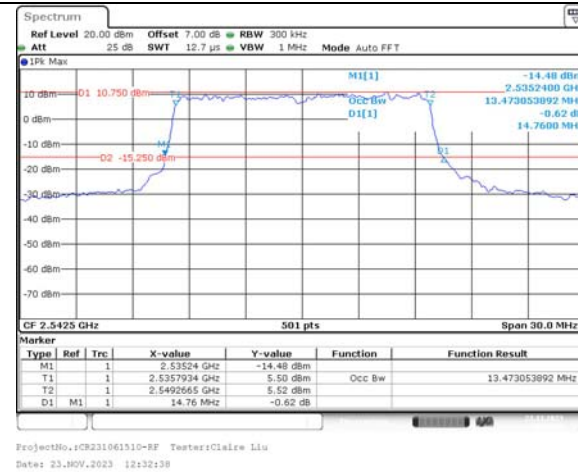
Occupied Bandwidth

Channel

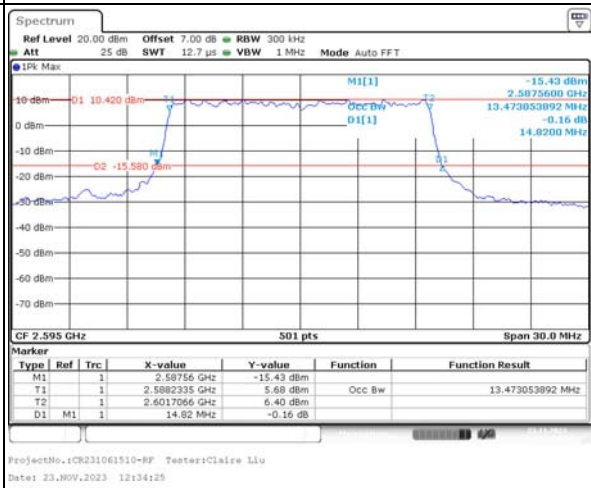
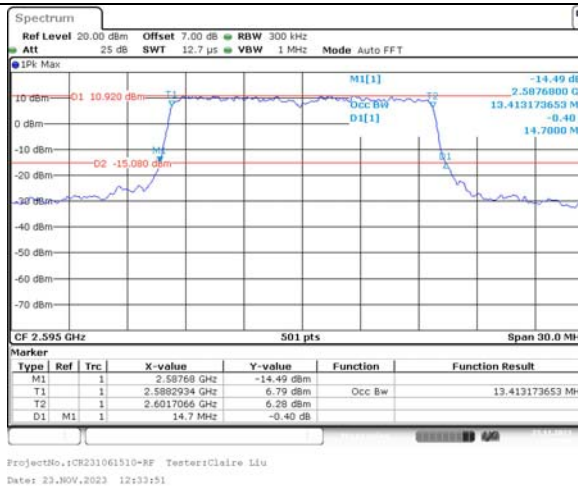
15MHz Bandwidth QPSK

15MHz Bandwidth 16QAM

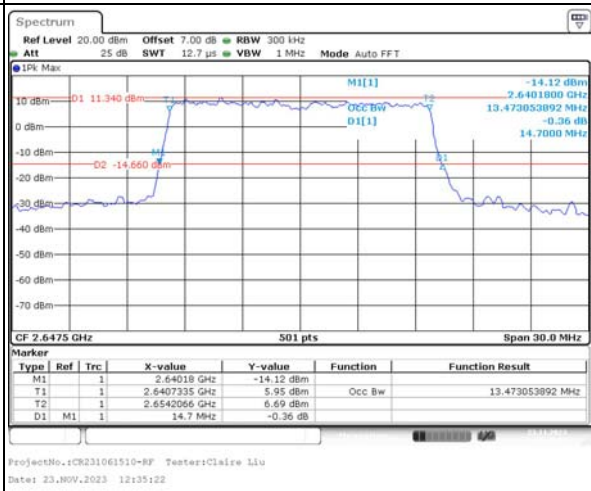
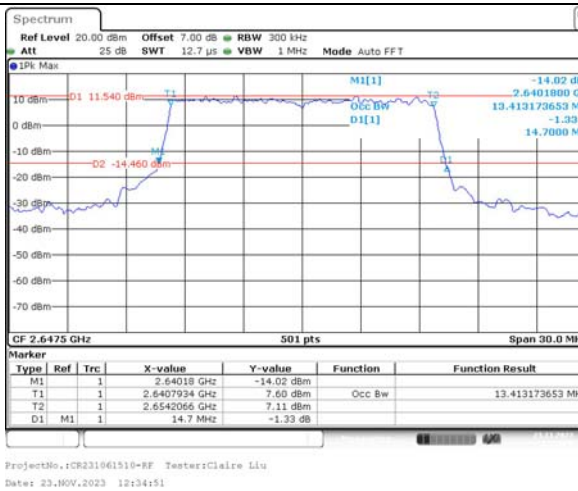
Lowest



Middle



Highest



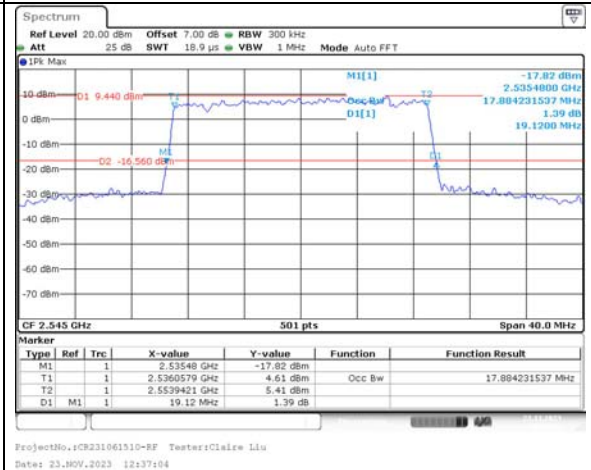
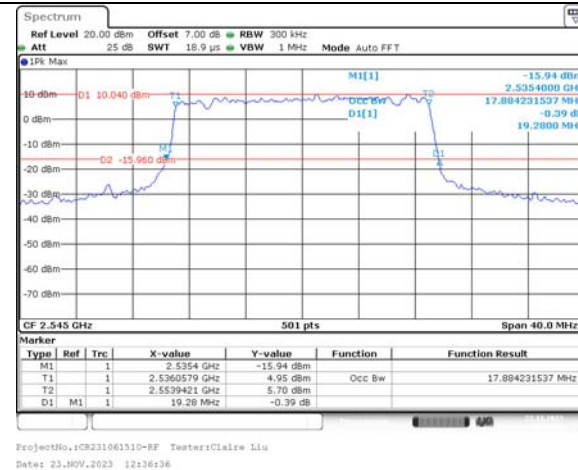
Occupied Bandwidth

Channel

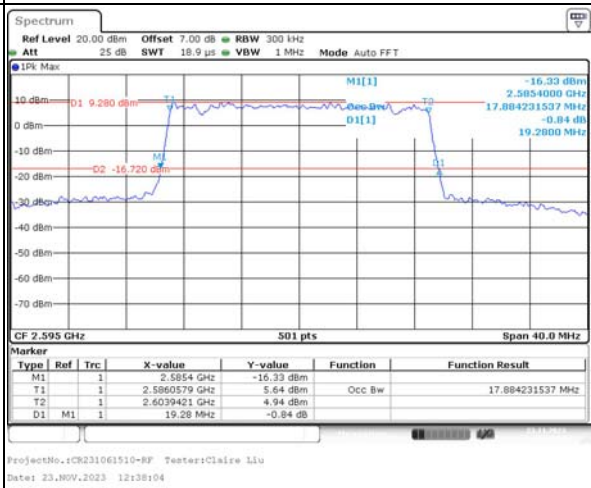
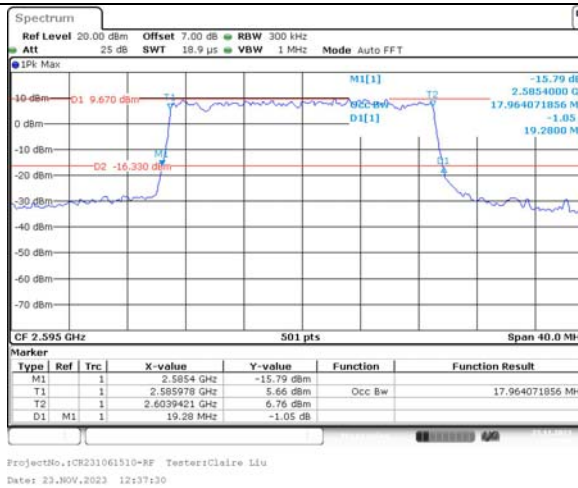
20MHz Bandwidth QPSK

20MHz Bandwidth 16QAM

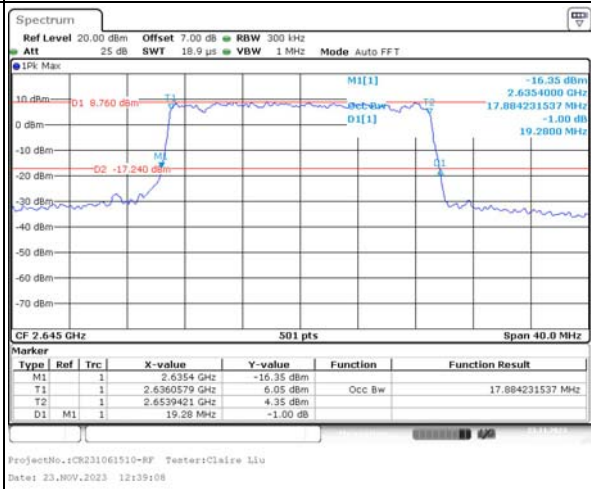
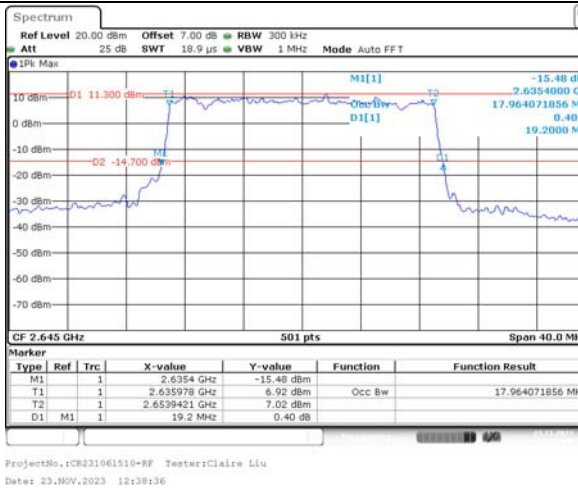
Lowest



Middle



Highest

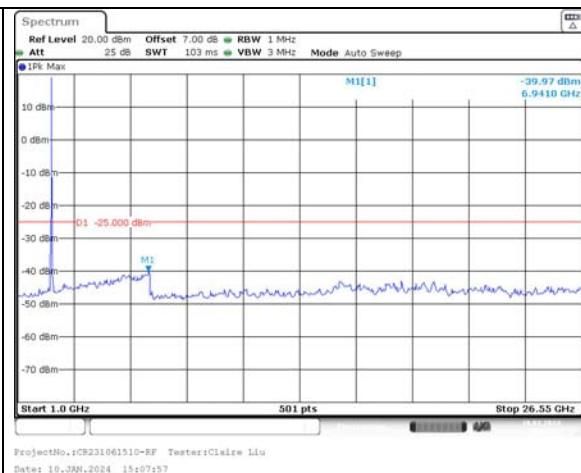
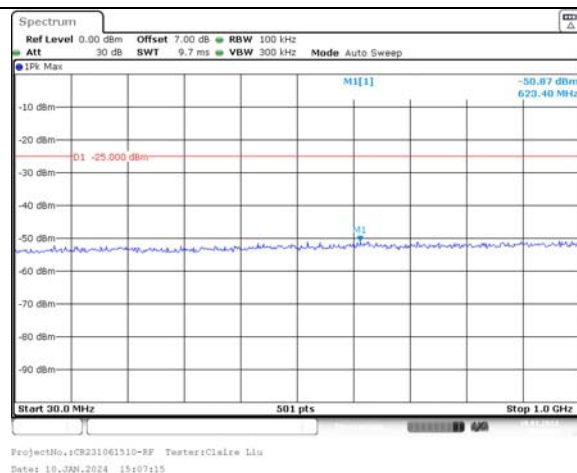


Spurious Emissions at Antenna Terminal

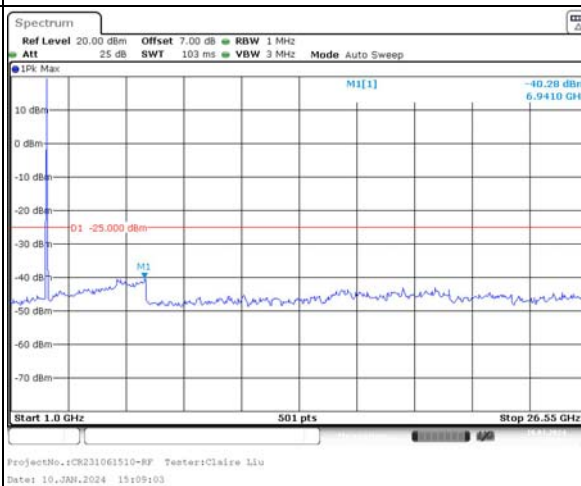
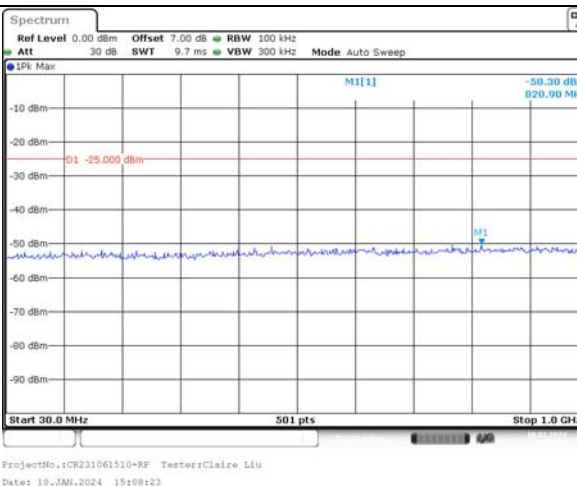
Channel

10MHz Bandwidth QPSK

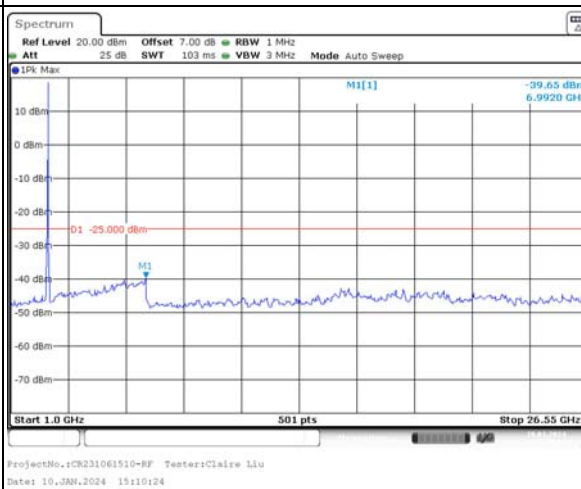
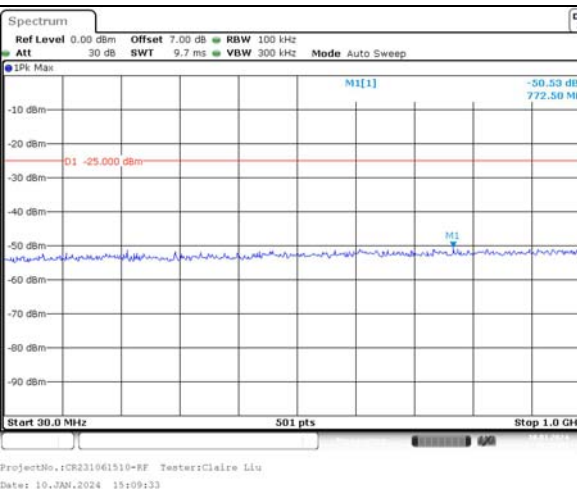
Lowest



Middle



Highest

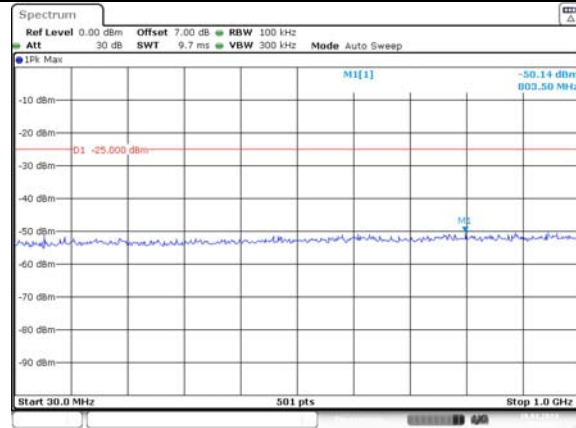


Spurious Emissions at Antenna Terminal

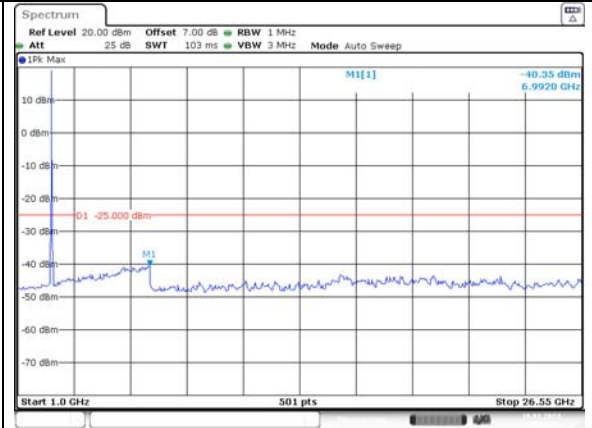
Channel

15MHz Bandwidth QPSK

Lowest

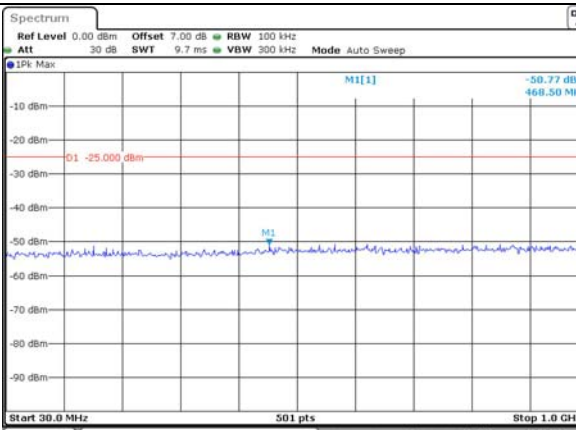


ProjectNo.:CR231061510-RF Testers:Claire Liu
Date: 10.JAN.2024 15:13:45

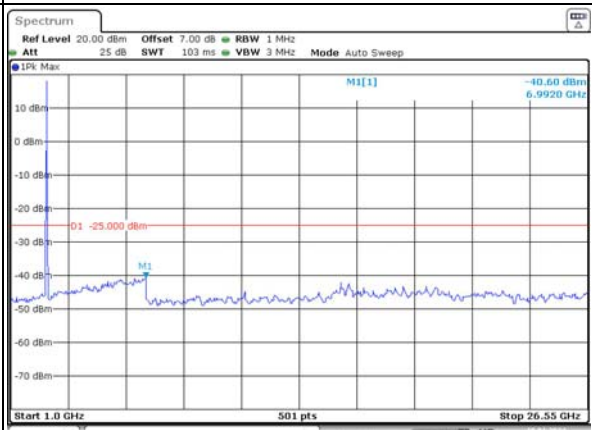


ProjectNo.:CR231061510-RF Testers:Claire Liu
Date: 10.JAN.2024 15:14:29

Middle

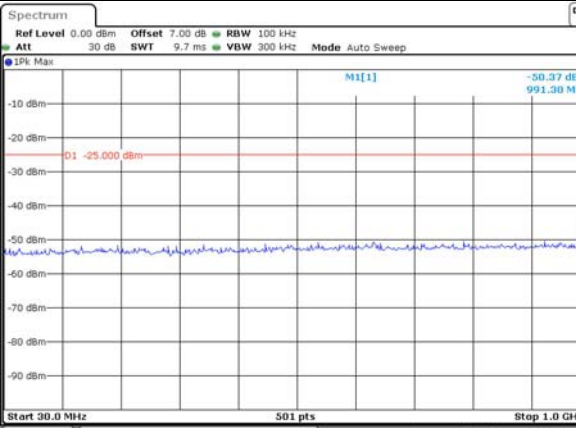


ProjectNo.:CR231061510-RF Testers:Claire Liu
Date: 10.JAN.2024 15:14:54

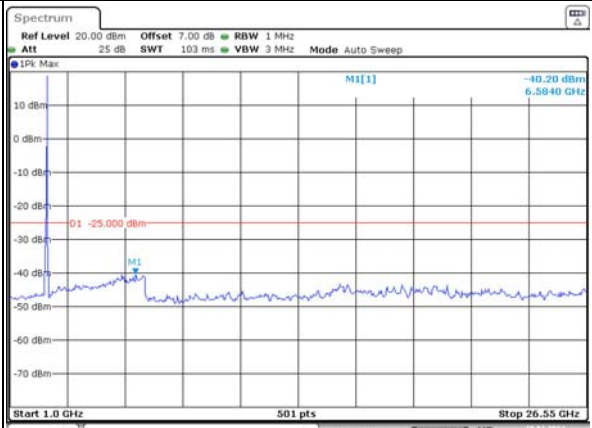


ProjectNo.:CR231061510-RF Testers:Claire Liu
Date: 10.JAN.2024 15:15:38

Highest



ProjectNo.:CR231061510-RF Testers:Claire Liu
Date: 10.JAN.2024 15:16:28



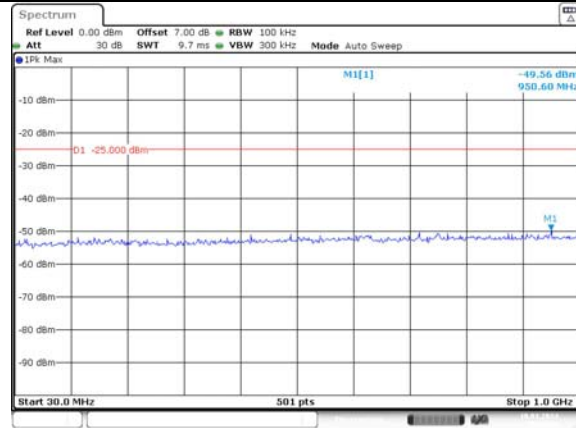
ProjectNo.:CR231061510-RF Testers:Claire Liu
Date: 10.JAN.2024 15:17:08

Spurious Emissions at Antenna Terminal

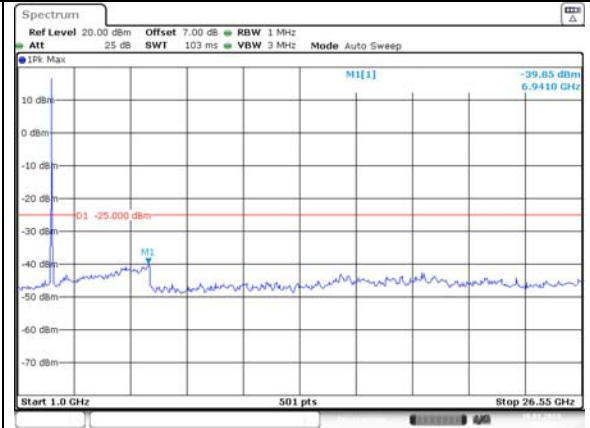
Channel

20MHz Bandwidth QPSK

Lowest

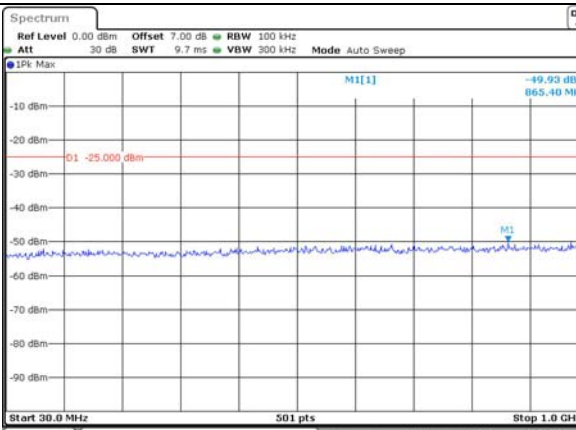


ProjectNo.:CR231061510-RF Testers:Claire Liu
Date: 10.JAN.2024 15:17:48

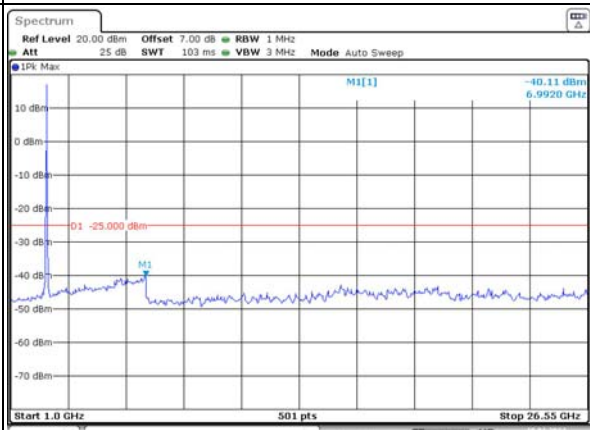


ProjectNo.:CR231061510-RF Testers:Claire Liu
Date: 10.JAN.2024 15:18:43

Middle

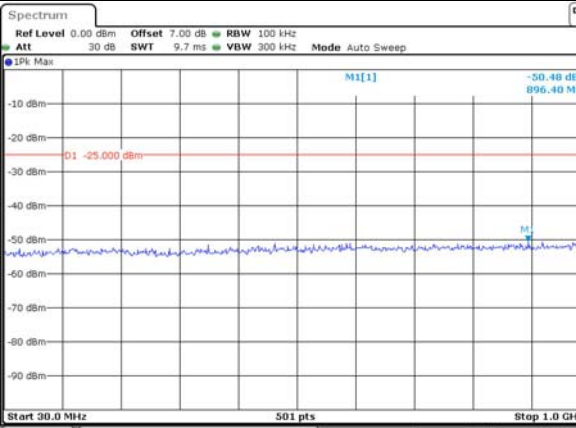


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Date: 10.JAN.2024 15:19:12

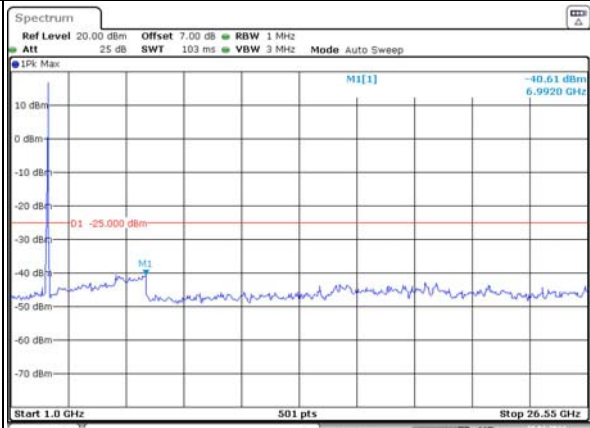


ProjectNo.:CR231061510-RF Testers:Claire Liu
Date: 10.JAN.2024 15:19:55

Highest



ProjectNo.:CR231061510-RF Testers:Claire Liu
Date: 10.JAN.2024 15:20:21



ProjectNo.:CR231061510-RF Testers:Claire Liu
Date: 10.JAN.2024 15:21:09